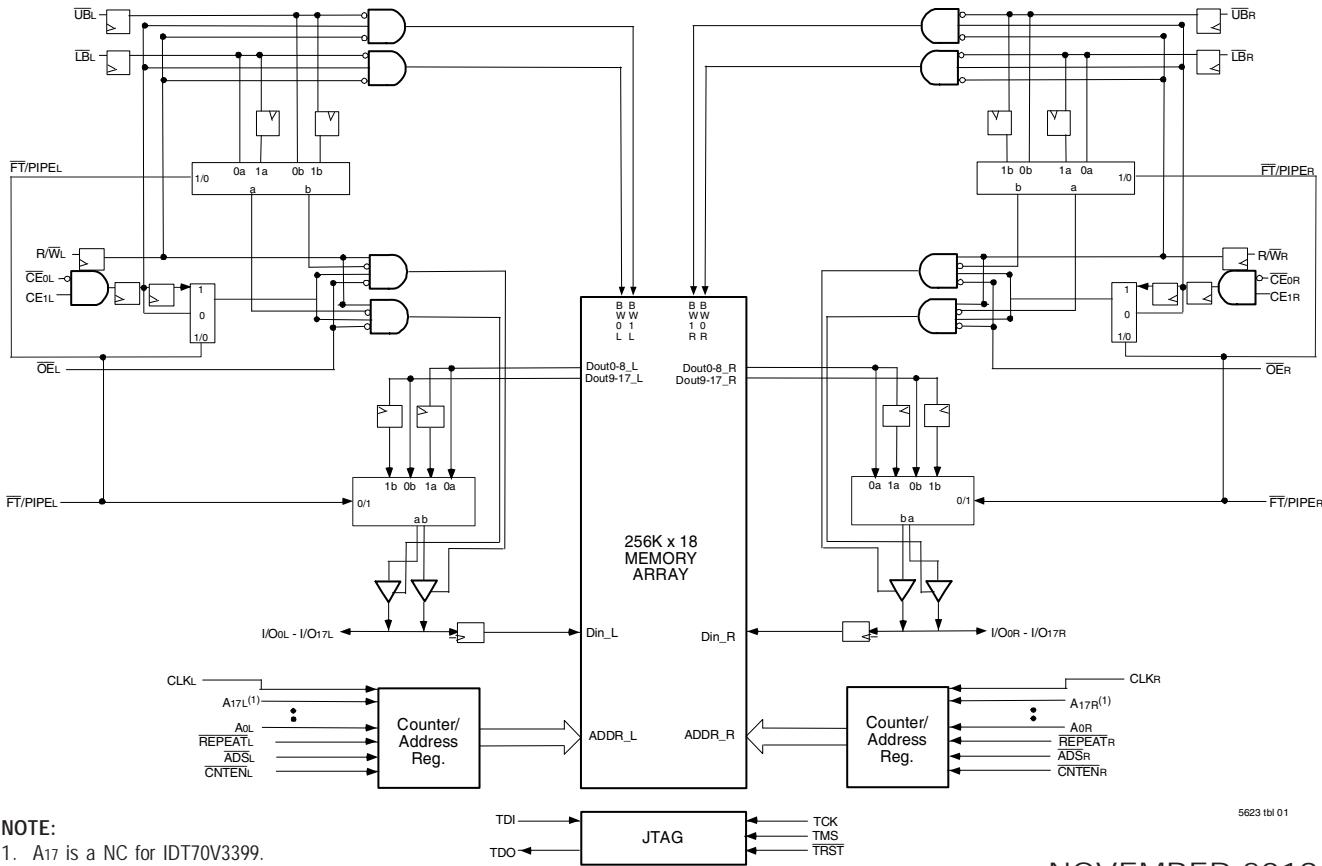


### Features:

- True Dual-Port memory cells which allow simultaneous access of the same memory location
- High-speed data access
  - Commercial: 3.6ns (166MHz)/4.2ns (133MHz) (max.)
  - Industrial: 4.2ns (133MHz) (max.)
- Selectable Pipelined or Flow-Through output mode
  - Due to limited pin count  $\overline{PL/FT}$  option is not supported on the 128-pin TQFP package. Device is pipelined outputs only on each port.
- Counter enable and repeat features
- Dual chip enables allow for depth expansion without additional logic
- Full synchronous operation on both ports
  - 6ns cycle time, 166MHz operation (6Gbps bandwidth)
  - Fast 3.6ns clock to data out
  - 1.7ns setup to clock and 0.5ns hold on all control, data, and address inputs @ 166MHz
  - Data input, address, byte enable and control registers
- Self-timed write allows fast cycle time
- Separate byte controls for multiplexed bus and bus matching compatibility
- Dual Cycle Deselect (DCD) for Pipelined Output mode
- LVTTL-compatible, single 3.3V ( $\pm 150mV$ ) power supply for core
- LVTTL compatible, selectable 3.3V ( $\pm 150mV$ ) or 2.5V ( $\pm 100mV$ ) power supply for I/Os and control signals on each port
- Industrial temperature range (-40°C to +85°C) is available at 133MHz.
- Available in a 128-pin Thin Quad Flatpack, 208-pin fine pitch Ball Grid Array, and 256-pin Ball Grid Array
- Supports JTAG features compliant to IEEE 1149.1
  - Due to limited pin count, JTAG is not supported on the 128-pin TQFP package
- Green parts available, see ordering information

### Functional Block Diagram



5623tbl 01

NOVEMBER 2019

**Description:**

The IDT70V3319/99 is a high-speed 256/128K x 18 bit synchronous Dual-Port RAM. The memory array utilizes Dual-Port memory cells to allow simultaneous access of any address from both ports. Registers on control, data, and address inputs provide minimal setup and hold times. The timing latitude provided by this approach allows systems to be designed with very short cycle times. With an input data register, the IDT70V3319/99 has been optimized for applications having unidirectional

or bidirectional data flow in bursts. An automatic power down feature, controlled by  $\overline{CE}_0$  and  $CE_1$ , permits the on-chip circuitry of each port to enter a very low standby power mode.

The 70V3319/99 can support an operating voltage of either 3.3V or 2.5V on one or both ports, controllable by the OPT pins. The power supply for the core of the device ( $V_{DD}$ ) remains at 3.3V.

**Pin Configuration<sup>(1,2,3,4,5)</sup>**

1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17		
I/O <sub>9L</sub>	NC	V <sub>SS</sub>	TDO	NC	A <sub>16L</sub>	A <sub>12L</sub>	A <sub>8L</sub>	NC	V <sub>DD</sub>	CLK <sub>L</sub>	$\overline{CNTEN}_L$	A <sub>4L</sub>	A <sub>0L</sub>	OPT <sub>L</sub>	NC	V <sub>SS</sub>	A	
NC	V <sub>SS</sub>	NC	TDI	A <sub>17L</sub> <sup>(1)</sup>	A <sub>13L</sub>	A <sub>9L</sub>	NC	$\overline{CE}_0L$	V <sub>SS</sub>	$\overline{ADS}_L$	A <sub>5L</sub>	A <sub>1L</sub>	V <sub>SS</sub>	V <sub>DDQR</sub>	I/O <sub>8L</sub>	NC	B	
V <sub>DDQL</sub>	I/O <sub>9R</sub>	V <sub>DDQR</sub>	PIPE/ $\overline{FT}_L$	NC	A <sub>14L</sub>	A <sub>10L</sub>	$\overline{UB}_L$	CE <sub>1L</sub>	V <sub>SS</sub>	R/ $\overline{W}_L$	A <sub>6L</sub>	A <sub>2L</sub>	V <sub>DD</sub>	I/O <sub>8R</sub>	NC	V <sub>SS</sub>	C	
NC	V <sub>SS</sub>	I/O <sub>10L</sub>	NC	A <sub>15L</sub>	A <sub>11L</sub>	A <sub>7L</sub>	$\overline{LB}_L$	V <sub>DD</sub>	$\overline{OE}_L$	REPEAT <sub>L</sub>	A <sub>3L</sub>	V <sub>DD</sub>	NC	V <sub>DDQL</sub>	I/O <sub>7L</sub>	I/O <sub>7R</sub>	D	
I/O <sub>11L</sub>	NC	V <sub>DDQR</sub>	I/O <sub>10R</sub>											I/O <sub>6L</sub>	NC	V <sub>SS</sub>	NC	E
V <sub>DDQL</sub>	I/O <sub>11R</sub>	NC	V <sub>SS</sub>											V <sub>SS</sub>	I/O <sub>6R</sub>	NC	V <sub>DDQR</sub>	F
NC	V <sub>SS</sub>	I/O <sub>12L</sub>	NC											NC	V <sub>DDQL</sub>	I/O <sub>5L</sub>	NC	G
V <sub>DD</sub>	NC	V <sub>DDQR</sub>	I/O <sub>12R</sub>											V <sub>DD</sub>	NC	V <sub>SS</sub>	I/O <sub>5R</sub>	H
V <sub>DDQL</sub>	V <sub>DD</sub>	V <sub>SS</sub>	V <sub>SS</sub>											V <sub>SS</sub>	V <sub>DD</sub>	V <sub>SS</sub>	V <sub>DDQR</sub>	J
I/O <sub>14R</sub>	V <sub>SS</sub>	I/O <sub>13R</sub>	V <sub>SS</sub>											I/O <sub>3R</sub>	V <sub>DDQL</sub>	I/O <sub>4R</sub>	V <sub>SS</sub>	K
NC	I/O <sub>14L</sub>	V <sub>DDQR</sub>	I/O <sub>13L</sub>											NC	I/O <sub>3L</sub>	V <sub>SS</sub>	I/O <sub>4L</sub>	L
V <sub>DDQL</sub>	NC	I/O <sub>15R</sub>	V <sub>SS</sub>											V <sub>SS</sub>	NC	I/O <sub>2R</sub>	V <sub>DDQR</sub>	M
NC	V <sub>SS</sub>	NC	I/O <sub>15L</sub>											I/O <sub>1R</sub>	V <sub>DDQL</sub>	NC	I/O <sub>2L</sub>	N
I/O <sub>16R</sub>	I/O <sub>16L</sub>	V <sub>DDQR</sub>	NC	TRST	A <sub>16R</sub>	A <sub>12R</sub>	A <sub>8R</sub>	NC	V <sub>DD</sub>	CLK <sub>R</sub>	$\overline{CNTEN}_R$	A <sub>4R</sub>	NC	I/O <sub>1L</sub>	V <sub>SS</sub>	NC	P	
V <sub>SS</sub>	NC	I/O <sub>17R</sub>	TCK	A <sub>17R</sub> <sup>(1)</sup>	A <sub>13R</sub>	A <sub>9R</sub>	NC	$\overline{CE}_0R$	V <sub>SS</sub>	$\overline{ADS}_R$	A <sub>5R</sub>	A <sub>1R</sub>	V <sub>SS</sub>	V <sub>DDQL</sub>	I/O <sub>0R</sub>	V <sub>DDQR</sub>	R	
NC	I/O <sub>17L</sub>	V <sub>DDQL</sub>	TMS	NC	A <sub>14R</sub>	A <sub>10R</sub>	$\overline{UB}_R$	CE <sub>1R</sub>	V <sub>SS</sub>	R/ $\overline{W}_R$	A <sub>6R</sub>	A <sub>2R</sub>	V <sub>SS</sub>	NC	V <sub>SS</sub>	NC	T	
V <sub>SS</sub>	NC	PIPE/ $\overline{FT}_R$	NC	A <sub>15R</sub>	A <sub>11R</sub>	A <sub>7R</sub>	$\overline{LB}_R$	V <sub>DD</sub>	$\overline{OE}_R$	REPEAT <sub>R</sub>	A <sub>3R</sub>	A <sub>0R</sub>	V <sub>DD</sub>	OPT <sub>R</sub>	NC	I/O <sub>0L</sub>	U	

5623 drw 02c

**NOTES:**

1. A<sub>17</sub> is a NC for IDT70V3399.
2. All V<sub>DD</sub> pins must be connected to 3.3V power supply.
3. All V<sub>DDQ</sub> pins must be connected to appropriate power supply: 3.3V if OPT pin for that port is set to V<sub>IH</sub> (3.3V), and 2.5V if OPT pin for that port is set to V<sub>IL</sub> (0V).
4. All V<sub>SS</sub> pins must be connected to ground supply.
5. Package body is approximately 15mm x 15mm x 1.4mm with 0.8mm ball pitch.
6. This package code is used to reference the package diagram.
7. This text does not indicate orientation of the actual part-marking.

Pin Configuration<sup>(1,2,3,4,5)</sup> (con't.)

70V3319/99

BC256<sup>(6)</sup>BCG256<sup>(6)</sup>256-Pin BGA  
Top View<sup>(7)</sup>

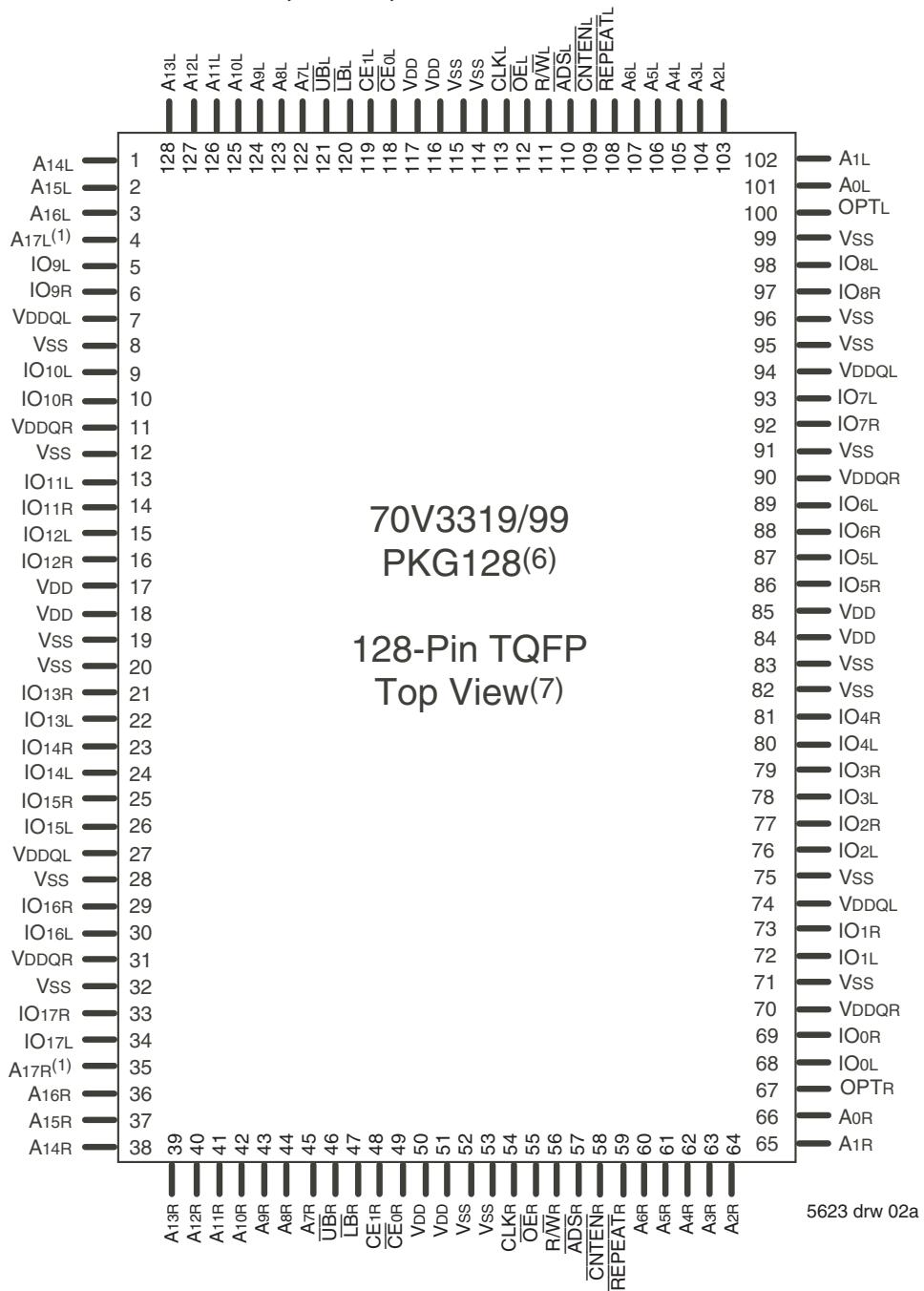
A1 NC	A2 TDI	A3 NC	A4 A17L <sup>(1)</sup>	A5 A14L	A6 A11L	A7 A8L	A8 NC	A9 CE1L	A10 OE <sub>L</sub>	A11 CNTEN <sub>L</sub>	A12 A5L	A13 A2L	A14 A0L	A15 NC	A16 NC
B1 NC	B2 NC	B3 TDO	B4 NC	B5 A15L	B6 A12L	B7 A9L	B8 UB <sub>L</sub>	B9 CE <sub>0L</sub>	B10 R/W <sub>L</sub>	B11 REPEAT <sub>L</sub>	B12 A4L	B13 A1L	B14 V <sub>DD</sub>	B15 NC	B16 NC
C1 NC	C2 I/O <sub>9L</sub>	C3 V <sub>SS</sub>	C4 A16L	C5 A13L	C6 A10L	C7 A7L	C8 NC	C9 LB <sub>L</sub>	C10 CLK <sub>L</sub>	C11 ADS <sub>L</sub>	C12 A6L	C13 A3L	C14 OPT <sub>L</sub>	C15 NC	C16 I/O <sub>8L</sub>
D1 NC	D2 I/O <sub>9R</sub>	D3 NC	D4 PIPE/FT <sub>L</sub>	D5 VDDQL	D6 VDDQR	D7 VDDQL	D8 VDDQR	D9 VDDQL	D10 VDDQR	D11 VDDQR	D12 VDDQR	D13 V <sub>DD</sub>	D14 NC	D15 NC	D16 I/O <sub>8R</sub>
E1 I/O <sub>10R</sub>	E2 I/O <sub>10L</sub>	E3 NC	E4 VDDQL	E5 V <sub>DD</sub>	E6 V <sub>DD</sub>	E7 V <sub>SS</sub>	E8 V <sub>SS</sub>	E9 V <sub>SS</sub>	E10 V <sub>SS</sub>	E11 V <sub>DD</sub>	E12 V <sub>DD</sub>	E13 VDDQR	E14 NC	E15 I/O <sub>7L</sub>	E16 I/O <sub>7R</sub>
F1 I/O <sub>11L</sub>	F2 NC	F3 I/O <sub>11R</sub>	F4 VDDQL	F5 V <sub>DD</sub>	F6 V <sub>SS</sub>	F7 V <sub>SS</sub>	F8 V <sub>SS</sub>	F9 V <sub>SS</sub>	F10 V <sub>SS</sub>	F11 V <sub>SS</sub>	F12 V <sub>DD</sub>	F13 VDDQR	F14 I/O <sub>6R</sub>	F15 NC	F16 I/O <sub>6L</sub>
G1 NC	G2 NC	G3 I/O <sub>12L</sub>	G4 VDDQR	G5 V <sub>SS</sub>	G6 V <sub>SS</sub>	G7 V <sub>SS</sub>	G8 V <sub>SS</sub>	G9 V <sub>SS</sub>	G10 V <sub>SS</sub>	G11 V <sub>SS</sub>	G12 V <sub>SS</sub>	G13 VDDQL	G14 I/O <sub>5L</sub>	G15 NC	G16 NC
H1 NC	H2 I/O <sub>12R</sub>	H3 NC	H4 VDDQR	H5 V <sub>SS</sub>	H6 V <sub>SS</sub>	H7 V <sub>SS</sub>	H8 V <sub>SS</sub>	H9 V <sub>SS</sub>	H10 V <sub>SS</sub>	H11 V <sub>SS</sub>	H12 V <sub>SS</sub>	H13 VDDQL	H14 NC	H15 NC	H16 I/O <sub>5R</sub>
J1 I/O <sub>13L</sub>	J2 I/O <sub>14R</sub>	J3 I/O <sub>13R</sub>	J4 VDDQL	J5 V <sub>SS</sub>	J6 V <sub>SS</sub>	J7 V <sub>SS</sub>	J8 V <sub>SS</sub>	J9 V <sub>SS</sub>	J10 V <sub>SS</sub>	J11 V <sub>SS</sub>	J12 V <sub>SS</sub>	J13 VDDQR	J14 I/O <sub>4R</sub>	J15 I/O <sub>3R</sub>	J16 I/O <sub>4L</sub>
K1 NC	K2 NC	K3 I/O <sub>14L</sub>	K4 VDDQL	K5 V <sub>SS</sub>	K6 V <sub>SS</sub>	K7 V <sub>SS</sub>	K8 V <sub>SS</sub>	K9 V <sub>SS</sub>	K10 V <sub>SS</sub>	K11 V <sub>SS</sub>	K12 V <sub>SS</sub>	K13 VDDQR	K14 NC	K15 NC	K16 I/O <sub>3L</sub>
L1 I/O <sub>15L</sub>	L2 NC	L3 I/O <sub>15R</sub>	L4 VDDQR	L5 V <sub>DD</sub>	L6 V <sub>SS</sub>	L7 V <sub>SS</sub>	L8 V <sub>SS</sub>	L9 V <sub>SS</sub>	L10 V <sub>SS</sub>	L11 V <sub>SS</sub>	L12 V <sub>DD</sub>	L13 VDDQL	L14 I/O <sub>2L</sub>	L15 NC	L16 I/O <sub>2R</sub>
M1 I/O <sub>16R</sub>	M2 I/O <sub>16L</sub>	M3 NC	M4 VDDQR	M5 V <sub>DD</sub>	M6 V <sub>SS</sub>	M7 V <sub>SS</sub>	M8 V <sub>SS</sub>	M9 V <sub>SS</sub>	M10 V <sub>SS</sub>	M11 V <sub>DD</sub>	M12 V <sub>DD</sub>	M13 VDDQL	M14 I/O <sub>1R</sub>	M15 I/O <sub>1L</sub>	M16 NC
N1 NC	N2 I/O <sub>17R</sub>	N3 NC	N4 PIPE/FT <sub>R</sub>	N5 VDDQR	N6 VDDQL	N7 VDDQL	N8 VDDQL	N9 VDDQR	N10 VDDQR	N11 VDDQL	N12 VDDQL	N13 V <sub>DD</sub>	N14 NC	N15 I/O <sub>0R</sub>	N16 NC
P1 NC	P2 I/O <sub>17L</sub>	P3 TMS	P4 A16R	P5 A13R	P6 A10R	P7 A7R	P8 NC	P9 LB <sub>R</sub>	P10 CLK <sub>R</sub>	P11 ADS <sub>R</sub>	P12 A6R	P13 A3R	P14 NC	P15 NC	P16 I/O <sub>0L</sub>
R1 NC	R2 NC	R3 TRST	R4 NC	R5 A15R	R6 A12R	R7 A9R	R8 UB <sub>R</sub>	R9 CE <sub>0R</sub>	R10 R/W <sub>R</sub>	R11 REPEAT <sub>R</sub>	R12 A4R	R13 A1R	R14 OPT <sub>R</sub>	R15 NC	R16 NC
T1 NC	T2 TCK	T3 NC	T4 A17R <sup>(1)</sup>	T5 A14R	T6 A11R	T7 A8R	T8 NC	T9 CE1R	T10 OE <sub>R</sub>	T11 CNTEN <sub>R</sub>	T12 A5R	T13 A2R	T14 A0R	T15 NC	T16 NC

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## NOTES:

1. A17 is a NC for IDT70V3399.
2. All V<sub>DD</sub> pins must be connected to 3.3V power supply.
3. All V<sub>DDO</sub> pins must be connected to appropriate power supply: 3.3V if OPT pin for that port is set to V<sub>IH</sub> (3.3V), and 2.5V if OPT pin for that port is set to V<sub>IL</sub> (0V).
4. All V<sub>SS</sub> pins must be connected to ground supply.
5. Package body is approximately 17mm x 17mm x 1.4mm, with 1.0mm ball-pitch.
6. This package code is used to reference the package diagram.
7. This text does not indicate orientation of the actual part-marking.

### Pin Configuration<sup>(1,2,3,4,5,8,9)</sup> (con't.)



## NOTES:

1. A17 is a NC for IDT70V3399.
2. All Vdd pins must be connected to 3.3V power supply.
3. All VDDO pins must be connected to appropriate power supply: 3.3V if OPT pin for that port is set to VIH (3.3V), and 2.5V if OPT pin for that port is set to VIL (0V).
4. All Vss pins must be connected to ground supply.
5. Package body is approximately 14mm x 20mm x 1.4mm.
6. This package code is used to reference the package diagram.
7. This text does not indicate orientation of the actual part-marking.
8. PIPE/FT option in PKG128 is not supported due to limitation in pin count. Device is pipelined outputs only on each port.
9. Due to the limited pin count, JTAG is not supported in the PKG128 package.

## Pin Names

Left Port	Right Port	Names
$\overline{CE}_{0L}$ , $CE_{1L}$	$\overline{CE}_{0R}$ , $CE_{1R}$	Chip Enables <sup>(6)</sup>
$R/\overline{W}_L$	$R/\overline{W}_R$	Read/Write Enable
$\overline{OE}_L$	$\overline{OE}_R$	Output Enable
$A_{0L} - A_{17L}^{(1)}$	$A_{0R} - A_{17R}^{(1)}$	Address
$I/O_{0L} - I/O_{17L}$	$I/O_{0R} - I/O_{17R}$	Data Input/Output
CLK <sub>L</sub>	CLK <sub>R</sub>	Clock
PIPE/ $\overline{FT}_L^{(5)}$	PIPE/ $\overline{FT}_R^{(5)}$	Pipeline/Flow-Through
$\overline{ADS}_L$	$\overline{ADS}_R$	Address Strobe Enable
CNTEN <sub>L</sub>	CNTEN <sub>R</sub>	Counter Enable
REPEAT <sub>L</sub>	REPEAT <sub>R</sub>	Counter Repeat <sup>(4)</sup>
$\overline{UB}_L$	$\overline{UB}_R$	Upper Byte Enable ( $I/O_9 - I/O_{17}$ ) <sup>(6)</sup>
$\overline{LB}_L$	$\overline{LB}_R$	Lower Byte Enable ( $I/O_0 - I/O_8$ ) <sup>(6)</sup>
V <sub>DDQL</sub>	V <sub>DDOR</sub>	Power (I/O Bus) (3.3V or 2.5V) <sup>(2)</sup>
OPT <sub>L</sub>	OPT <sub>R</sub>	Option for selecting V <sub>DDOX</sub> <sup>(2,3)</sup>
V <sub>DD</sub>		Power (3.3V) <sup>(2)</sup>
V <sub>SS</sub>		Ground (0V)
TDI		Test Data Input
TDO		Test Data Output
TCK		Test Logic Clock (10MHz)
TMS		Test Mode Select
$\overline{TRST}$		Reset (Initialize TAP Controller)

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## NOTES:

1. A<sub>17</sub> is a NC for IDT70V3399.
2. V<sub>DD</sub>, OPT<sub>x</sub>, and V<sub>DDOX</sub> must be set to appropriate operating levels prior to applying inputs on the I/Os and controls for that port.
3. OPT<sub>x</sub> selects the operating voltage levels for the I/Os and controls on that port. If OPT<sub>x</sub> is set to VIH (3.3V), then that port's I/Os and controls will operate at 3.3V levels and V<sub>DDOX</sub> must be supplied at 3.3V. If OPT<sub>x</sub> is set to VIL (0V), then that port's I/Os and address controls will operate at 2.5V levels and V<sub>DDOX</sub> must be supplied at 2.5V. The OPT pins are independent of one another—both ports can operate at 3.3V levels, both can operate at 2.5V levels, or either can operate at 3.3V with the other at 2.5V.
4. When REPEAT<sub>x</sub> is asserted, the counter will reset to the last valid address loaded via ADS<sub>x</sub>.
5. PIPE/ $\overline{FT}$  option in PK-128 package is not supported due to limitation in pin count. Device is pipelined output mode only on each port.
6. Chip Enables and Byte Enables are double buffered when PL/ $\overline{FT}$  = VIH, i.e., the signals take two cycles to deselect.

Truth Table I—Read/Write and Enable Control<sup>(1,2,3)</sup>

<u><b>OE</b></u>	<u><b>CLK</b></u>	<u><b>CE<sub>0</sub></b></u>	<u><b>CE<sub>1</sub></b></u>	<u><b>UB</b></u>	<u><b>LB</b></u>	<u><b>R/W</b></u>	<u><b>Upper Byte I/O<sub>9-17</sub></b></u>	<u><b>Lower Byte I/O<sub>0-8</sub></b></u>	<u><b>MODE</b></u>
X	↑	H	X	X	X	X	High-Z	High-Z	Deselected—Power Down
X	↑	X	L	X	X	X	High-Z	High-Z	Deselected—Power Down
X	↑	L	H	H	H	X	High-Z	High-Z	Both Bytes Deselected
X	↑	L	H	H	L	L	High-Z	DIN	Write to Lower Byte Only
X	↑	L	H	L	H	L	DIN	High-Z	Write to Upper Byte Only
X	↑	L	H	L	L	L	DIN	DIN	Write to Both Bytes
L	↑	L	H	H	L	H	High-Z	DOUT	Read Lower Byte Only
L	↑	L	H	L	H	H	DOUT	High-Z	Read Upper Byte Only
L	↑	L	H	L	L	H	DOUT	DOUT	Read Both Bytes
H	↑	L	H	L	L	X	High-Z	High-Z	Outputs Disabled

5623 tbl 02

## NOTES:

1. "H" =  $V_{IH}$ , "L" =  $V_{IL}$ , "X" = Don't Care.
2. ADS, CNTEN, REPEAT = X.
3. OE is an asynchronous input signal.

Truth Table II—Address Counter Control<sup>(1,2)</sup>

<u><b>External Address</b></u>	<u><b>Previous Internal Address</b></u>	<u><b>Internal Address Used</b></u>	<u><b>CLK</b></u>	<u><b>ADS</b></u>	<u><b>CNTEN</b></u>	<u><b>REPEAT<sup>(6)</sup></b></u>	<u><b>I/O<sup>(3)</sup></b></u>	<u><b>MODE</b></u>
X	X	An	↑	X	X	L <sup>(4)</sup>	D <sub>0</sub> (0)	Counter Reset to last valid <u>ADS</u> load
An	X	An	↑	L <sup>(4)</sup>	X	H	D <sub>0</sub> (n)	External Address Used
An	Ap	Ap	↑	H	H	H	D <sub>0</sub> (p)	External Address Blocked—Counter disabled (Ap reused)
X	Ap	Ap + 1	↑	H	L <sup>(5)</sup>	H	D <sub>0</sub> (p+1)	Counter Enabled—Internal Address generation

5623 tbl 03

## NOTES:

1. "H" =  $V_{IH}$ , "L" =  $V_{IL}$ , "X" = Don't Care.
2. Read and write operations are controlled by the appropriate setting of R/W, CE<sub>0</sub>, CE<sub>1</sub>, UB, LB and OE.
3. Outputs configured in flow-through output mode: if outputs are in pipelined mode the date out will be delayed by one cycle.
4. ADS and REPEAT are independent of all other memory control signals including CE<sub>0</sub>, CE<sub>1</sub> and UB, LB.
5. The address counter advances if CNTEN =  $V_{IL}$  on the rising edge of CLK, regardless of all other memory control signals including CE<sub>0</sub>, CE<sub>1</sub>, UB, LB.
6. When REPEAT is asserted, the counter will reset to the last valid address loaded via ADS. This value is not set at power-up: a known location should be loaded via ADS during initialization if desired. Any subsequent ADS access during operations will update the REPEAT address location.

70V3319/99S

High-Speed 3.3V 256/128K x 18 Dual-Port Synchronous Static RAM

Industrial and Commercial Temperature Ranges

Recommended Operating Temperature and Supply Voltage<sup>(1)</sup>

Grade	Ambient Temperature	GND	V <sub>DD</sub>
Commercial	0°C to +70°C	0V	3.3V $\pm$ 150mV
Industrial	-40°C to +85°C	0V	3.3V $\pm$ 150mV

5623 Ibl 04

## NOTES:

1. This is the parameter TA. This is the "instant on" case temperature.

Recommended DC Operating Conditions with V<sub>DDQ</sub> at 2.5V

Symbol	Parameter	Min.	Typ.	Max.	Unit
V <sub>DD</sub>	Core Supply Voltage	3.15	3.3	3.45	V
V <sub>DDQ</sub>	I/O Supply Voltage <sup>(3)</sup>	2.4	2.5	2.6	V
V <sub>SS</sub>	Ground	0	0	0	V
V <sub>IH</sub>	Input High Voltage (Address & Control Inputs)	1.7	—	V <sub>DDQ</sub> + 100mV <sup>(2)</sup>	V
V <sub>IH</sub>	Input High Voltage - I/O <sup>(3)</sup>	1.7	—	V <sub>DDQ</sub> + 100mV <sup>(2)</sup>	V
V <sub>IL</sub>	Input Low Voltage	-0.3 <sup>(1)</sup>	—	0.7	V

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## NOTES:

1. Undershoot of V<sub>IL</sub>  $\geq$  -1.5V for pulse width less than 10ns is allowed.
2. V<sub>TERM</sub> must not exceed V<sub>DDQ</sub> + 100mV.
3. To select operation at 2.5V levels on the I/Os and controls of a given port, the OPT pin for that port must be set to V<sub>IL</sub> (0V), and V<sub>DDQ</sub> for that port must be supplied as indicated above.

Absolute Maximum Ratings<sup>(1)</sup>

Symbol	Rating	Commercial & Industrial	Unit
V <sub>TERM</sub> <sup>(2)</sup>	Terminal Voltage with Respect to GND	-0.5 to +4.6	V
T <sub>BIA</sub> <sup>(3)</sup>	Temperature Under Bias	-55 to +125	°C
T <sub>STG</sub>	Storage Temperature	-65 to +150	°C
T <sub>JN</sub>	Junction Temperature	+150	°C
I <sub>OUT</sub>	DC Output Current	50	mA

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## NOTES:

1. Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
2. V<sub>TERM</sub> must not exceed V<sub>DD</sub> + 150mV for more than 25% of the cycle time or 4ns maximum, and is limited to  $\leq$  20mA for the period of V<sub>TERM</sub>  $\geq$  V<sub>DD</sub> + 150mV.
3. Ambient Temperature Under Bias. No AC Conditions. Chip Deselected.

Recommended DC Operating Conditions with V<sub>DDQ</sub> at 3.3V

Symbol	Parameter	Min.	Typ.	Max.	Unit
V <sub>DD</sub>	Core Supply Voltage	3.15	3.3	3.45	V
V <sub>DDQ</sub>	I/O Supply Voltage <sup>(3)</sup>	3.15	3.3	3.45	V
V <sub>SS</sub>	Ground	0	0	0	V
V <sub>IH</sub>	Input High Voltage (Address & Control Inputs) <sup>(3)</sup>	2.0	—	V <sub>DDQ</sub> + 150mV <sup>(2)</sup>	V
V <sub>IH</sub>	Input High Voltage - I/O <sup>(3)</sup>	2.0	—	V <sub>DDQ</sub> + 150mV <sup>(2)</sup>	V
V <sub>IL</sub>	Input Low Voltage	-0.3 <sup>(1)</sup>	—	0.8	V

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## NOTES:

1. Undershoot of V<sub>IL</sub>  $\geq$  -1.5V for pulse width less than 10ns is allowed.
2. V<sub>TERM</sub> must not exceed V<sub>DDQ</sub> + 150mV.
3. To select operation at 3.3V levels on the I/Os and controls of a given port, the OPT pin for that port must be set to V<sub>IH</sub> (3.3V), and V<sub>DDQ</sub> for that port must be supplied as indicated above.

Capacitance<sup>(1)</sup>(TA = +25°C, F = 1.0MHz)

Symbol	Parameter	Conditions <sup>(2)</sup>	Max.	Unit
C <sub>IN</sub>	Input Capacitance	V <sub>IN</sub> = 3dV	8	pF
C <sub>OUT</sub> <sup>(3)</sup>	Output Capacitance	V <sub>OUT</sub> = 3dV	10.5	pF

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## NOTES:

1. These parameters are determined by device characterization, but are not production tested.
2. 3dV references the interpolated capacitance when the input and output switch from 0V to 3V or from 3V to 0V.
3. C<sub>OUT</sub> also references C<sub>IO</sub>.

DC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range (V<sub>DD</sub> = 3.3V ± 150mV)

Symbol	Parameter	Test Conditions	70V3319/99S		Unit
			Min.	Max.	
I <sub>L</sub>	Input Leakage Current <sup>(1)</sup>	V <sub>DDQ</sub> = Max., V <sub>IN</sub> = 0V to V <sub>DDQ</sub>	—	10	µA
I <sub>O</sub>	Output Leakage Current <sup>(1)</sup>	CE <sub>0</sub> = V <sub>IH</sub> or CE <sub>1</sub> = V <sub>IL</sub> , V <sub>OUT</sub> = 0V to V <sub>DDQ</sub>	—	10	µA
V <sub>OL</sub> (3.3V)	Output Low Voltage <sup>(2)</sup>	I <sub>OL</sub> = +4mA, V <sub>DDQ</sub> = Min.	—	0.4	V
V <sub>OH</sub> (3.3V)	Output High Voltage <sup>(2)</sup>	I <sub>OH</sub> = -4mA, V <sub>DDQ</sub> = Min.	2.4	—	V
V <sub>OL</sub> (2.5V)	Output Low Voltage <sup>(2)</sup>	I <sub>OL</sub> = +2mA, V <sub>DDQ</sub> = Min.	—	0.4	V
V <sub>OH</sub> (2.5V)	Output High Voltage <sup>(2)</sup>	I <sub>OH</sub> = -2mA, V <sub>DDQ</sub> = Min.	2.0	—	V

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## NOTE:

1. At V<sub>DD</sub> ≤ 2.0V leakages are undefined.
2. V<sub>DDQ</sub> is selectable (3.3V/2.5V) via OPT pins. Refer to p.5 for details.

DC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range<sup>(3)</sup> (V<sub>DD</sub> = 3.3V ± 150mV)

Symbol	Parameter	Test Condition	Version	70V3319/99S166		70V3319/99S133		Unit	
				Typ. <sup>(4)</sup>	Max.	Typ. <sup>(4)</sup>	Max.		
I <sub>DD</sub>	Dynamic Operating Current (Both Ports Active)	$\overline{CE}_L$ and $\overline{CE}_R = V_{IL}$ , Outputs Disabled, $f = f_{MAX}^{(1)}$	COM'L	S	370	500	320	400	mA
			IND	S	—	—	320	480	
I <sub>SB1</sub>	Standby Current (Both Ports - TTL Level Inputs)	$\overline{CE}_L = \overline{CE}_R = V_{IH}$ , Outputs Disabled, $f = f_{MAX}^{(1)}$	COM'L	S	125	200	115	160	mA
			IND	S	—	—	115	195	
I <sub>SB2</sub>	Standby Current (One Port - TTL Level Inputs)	$\overline{CE}^{(A)} = V_{IL}$ and $\overline{CE}^{(B)} = V_{IH}^{(5)}$ Active Port Outputs Disabled, $f=f_{MAX}^{(1)}$	COM'L	S	250	350	220	290	mA
			IND	S	—	—	220	350	
I <sub>SB3</sub>	Full Standby Current (Both Ports - CMOS Level Inputs)	Both Ports Outputs Disabled $\overline{CE}_L$ and $\overline{CE}_R \geq V_{DDQ} - 0.2V$ , $V_{IN} \geq V_{DDQ} - 0.2V$ or $V_{IN} \leq 0.2V$ , $f = 0^{(2)}$	COM'L	S	15	30	15	30	mA
			IND	S	—	—	15	40	
I <sub>SB4</sub>	Full Standby Current (One Port - CMOS Level Inputs)	$\overline{CE}^{(A)} \leq 0.2V$ and $\overline{CE}^{(B)} \geq V_{DDQ} - 0.2V^{(5)}$ $V_{IN} \geq V_{DDQ} - 0.2V$ or $V_{IN} \leq 0.2V$ Active Port, Outputs Disabled, $f = f_{MAX}^{(1)}$	COM'L	S	250	350	220	290	mA
			IND	S	—	—	220	350	

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## NOTES:

- At  $f = f_{MAX}$ , address and control lines (except Output Enable) are cycling at the maximum frequency clock cycle of  $1/t_{cyc}$ , using "AC TEST CONDITIONS" at input levels of GND to 3V.
- $f = 0$  means no address, clock, or control lines change. Applies only to input at CMOS level standby.
- Port "A" may be either left or right port. Port "B" is the opposite from port "A".
- $V_{DD} = 3.3V$ ,  $T_A = 25^\circ C$  for Typ. and are not production tested.  $I_{DD DC}(f=0) = 120mA$  (Typ).
- $\overline{CE}_X = V_{IL}$  means  $\overline{CE}_{0X} = V_{IL}$  and  $CE_{1X} = V_{IH}$   
 $\overline{CE}_X = V_{IH}$  means  $\overline{CE}_{0X} = V_{IH}$  or  $CE_{1X} = V_{IL}$   
 $\overline{CE}_X \leq 0.2V$  means  $\overline{CE}_{0X} \leq 0.2V$  and  $CE_{1X} \geq V_{DDQ} - 0.2V$   
 $\overline{CE}_X \geq V_{DDQ} - 0.2V$  means  $\overline{CE}_{0X} \geq V_{DDQ} - 0.2V$  or  $CE_{1X} \leq 0.2V$   
"X" represents "L" for left port or "R" for right port.

AC Test Conditions (V<sub>DDQ</sub> - 3.3V/2.5V)

Input Pulse Levels (Address & Controls)	GND to 3.0V/GND to 2.4V
Input Pulse Levels (I/Os)	GND to 3.0V/GND to 2.4V
Input Rise/Fall Times	2ns
Input Timing Reference Levels	1.5V/1.25V
Output Reference Levels	1.5V/1.25V
Output Load	Figures 1 and 2

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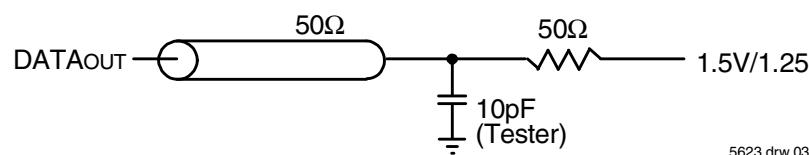
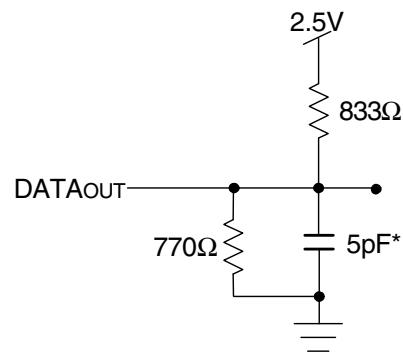
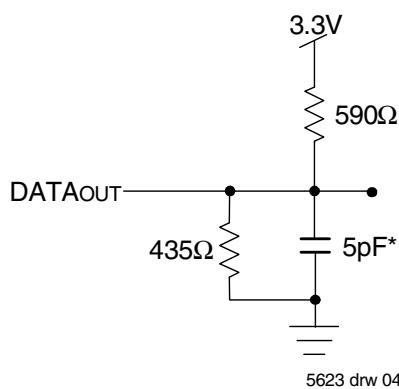


Figure 1. AC Output Test load.

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5623 drw 04

Figure 2. Output Test Load  
(For tckLZ, tckHZ, tolZ, and toHZ).

\*Including scope and jig.

10.5pF is the I/O capacitance of this device, and 10pF is the AC Test Load Capacitance.

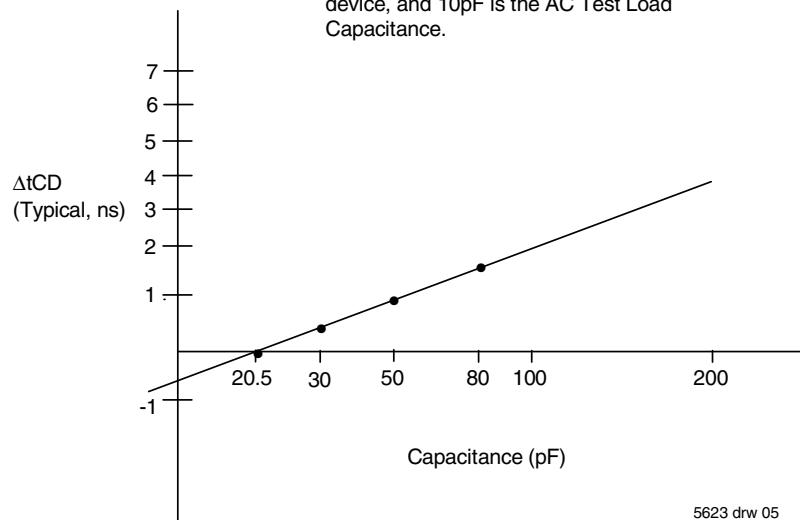


Figure 3. Typical Output Derating (Lumped Capacitive Load).

AC Electrical Characteristics Over the Operating Temperature Range  
(Read and Write Cycle Timing)<sup>(2,3)</sup> (VDD = 3.3V ± 150mV, TA = 0°C to +70°C)

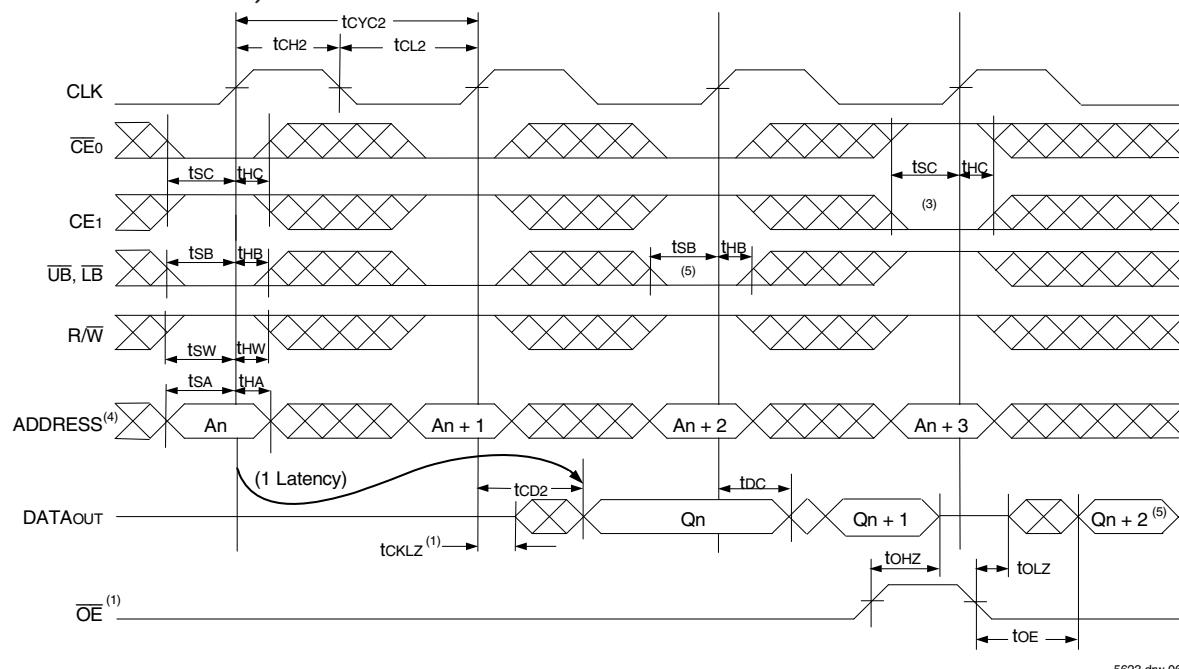
		70V3319/99S166 Com'l Only		70V3319/99S133 Com'l & Ind		
Symbol	Parameter	Min.	Max.	Min.	Max.	Unit
tCyc1	Clock Cycle Time (Flow-Through) <sup>(1)</sup>	20	—	25	—	ns
tCyc2	Clock Cycle Time (Pipelined) <sup>(1)</sup>	6	—	7.5	—	ns
tCh1	Clock High Time (Flow-Through) <sup>(1)</sup>	6	—	7	—	ns
tCl1	Clock Low Time (Flow-Through) <sup>(1)</sup>	6	—	7	—	ns
tCh2	Clock High Time (Pipelined) <sup>(2)</sup>	2.1	—	2.6	—	ns
tCl2	Clock Low Time (Pipelined) <sup>(1)</sup>	2.1	—	2.6	—	ns
tSA	Address Setup Time	1.7	—	1.8	—	ns
tHA	Address Hold Time	0.5	—	0.5	—	ns
tSC	Chip Enable Setup Time	1.7	—	1.8	—	ns
tHC	Chip Enable Hold Time	0.5	—	0.5	—	ns
tSB	Byte Enable Setup Time	1.7	—	1.8	—	ns
tHB	Byte Enable Hold Time	0.5	—	0.5	—	ns
tSW	R/W Setup Time	1.7	—	1.8	—	ns
tHW	R/W Hold Time	0.5	—	0.5	—	ns
tSD	Input Data Setup Time	1.7	—	1.8	—	ns
tHD	Input Data Hold Time	0.5	—	0.5	—	ns
tSAD	ADS Setup Time	1.7	—	1.8	—	ns
tHAD	ADS Hold Time	0.5	—	0.5	—	ns
tSCN	CNTEN Setup Time	1.7	—	1.8	—	ns
tHCN	CNTEN Hold Time	0.5	—	0.5	—	ns
tSRPT	REPEAT Setup Time	1.7	—	1.8	—	ns
tHRPT	REPEAT Hold Time	0.5	—	0.5	—	ns
tOE	Output Enable to Data Valid	—	4.0	—	4.2	ns
tOLZ	Output Enable to Output Low-Z	1	—	1	—	ns
tOHZ	Output Enable to Output High-Z	1	3.6	1	4.2	ns
tCD1	Clock to Data Valid (Flow-Through) <sup>(1)</sup>	—	12	—	15	ns
tCD2	Clock to Data Valid (Pipelined) <sup>(1)</sup>	—	3.6	—	4.2	ns
tDC	Data Output Hold After Clock High	1	—	1	—	ns
tCKHZ	Clock High to Output High-Z	1	3	1	3	ns
tCKLZ	Clock High to Output Low-Z	1	—	1	—	ns
<b>Port-to-Port Delay</b>						
tCO	Clock-to-Clock Offset	5	—	6	—	ns

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## NOTES:

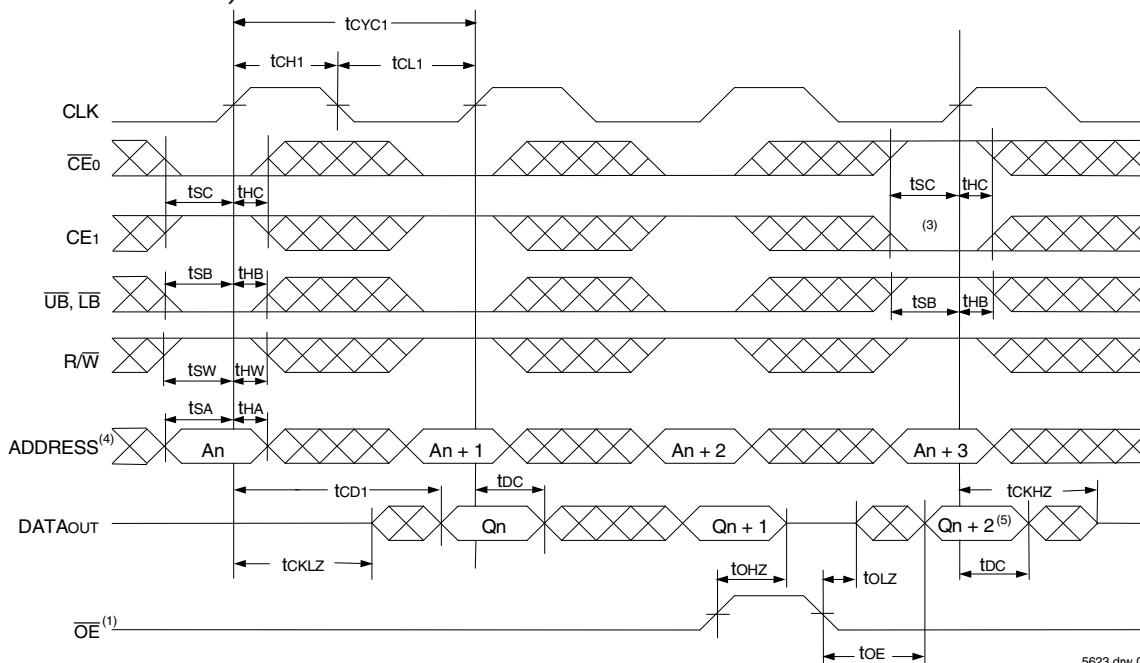
- The Pipelined output parameters (tCyc2, tCD2) apply to either or both left and right ports when  $\overline{FT}/PIPE_X = V_{IH}$ . Flow-through parameters (tCyc1, tCD1) apply when  $\overline{FT}/PIPE = V_{IL}$  for that port.
- All input signals are synchronous with respect to the clock except for the asynchronous Output Enable ( $\overline{OE}$ ) and  $\overline{FT}/PIPE$ .  $\overline{FT}/PIPE$  should be treated as a DC signal, i.e. steady state during operation.
- These values are valid for either level of VDDO (3.3V/2.5V). See page 5 for details on selecting the desired operating voltage levels for each port.

## Timing Waveform of Read Cycle for Pipelined Operation ( $\overline{FT}/PIPE'x' = V_{IH}$ )<sup>(2)</sup>



5623 drw 06

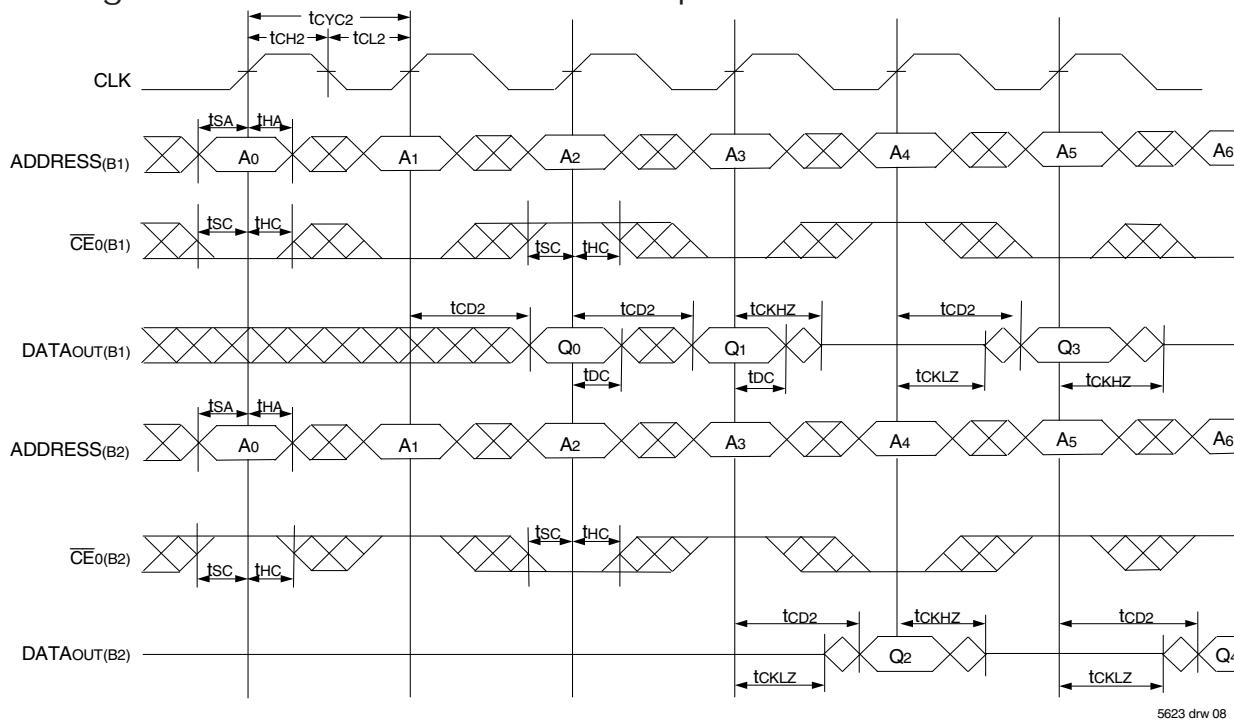
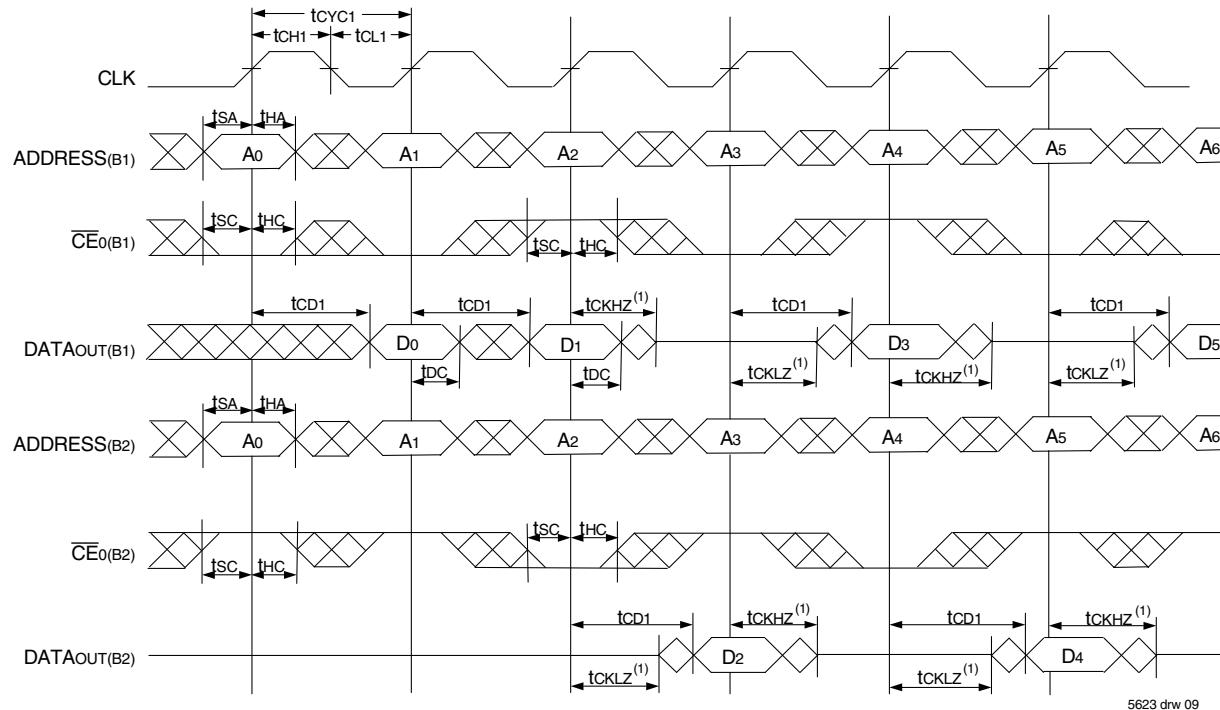
## Timing Waveform of Read Cycle for Flow-through Output ( $\overline{FT}/PIPE''x'' = V_{IL}$ )<sup>(2,6)</sup>



5623 drw 07

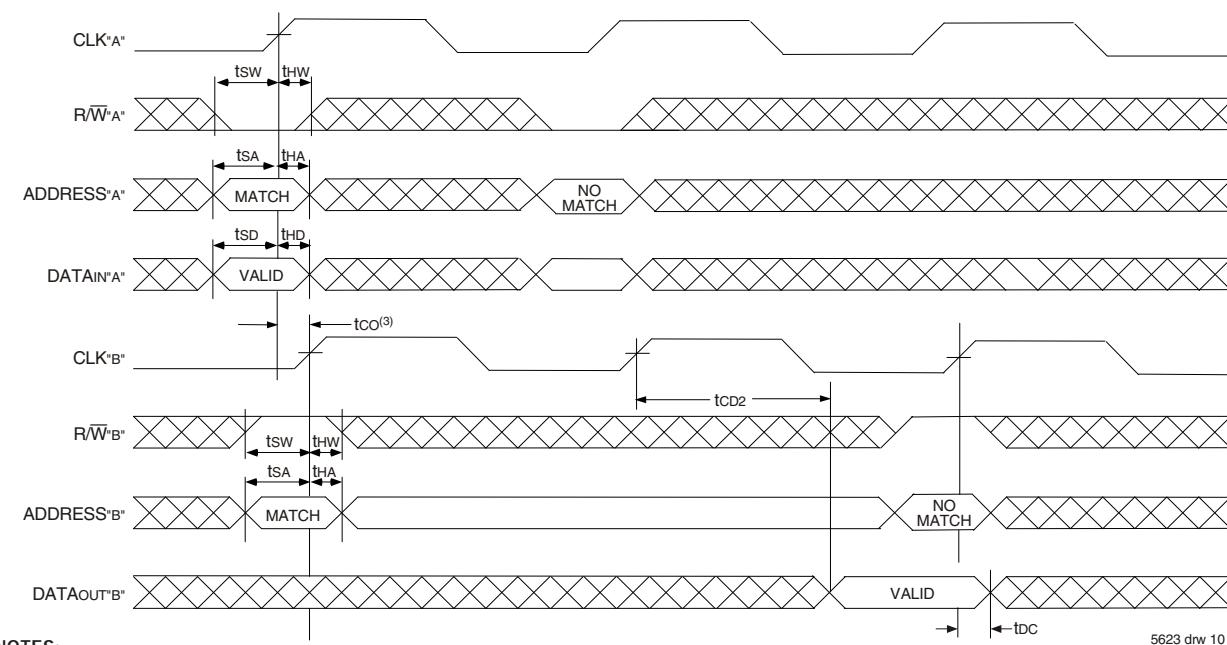
**NOTES:**

1.  $\overline{OE}$  is asynchronously controlled; all other inputs are synchronous to the rising clock edge.
2.  $\overline{ADS} = V_{IL}$ ,  $\overline{CNTEN}$  and  $\overline{REPEAT} = V_{IH}$ .
3. The output is disabled (High-Impedance state) by  $\overline{CE}_0 = V_{IH}$ ,  $CE_1 = V_{IL}$ ,  $\overline{UB}, LB = V_{IH}$  following the next rising edge of the clock. Refer to Truth Table 1.
4. Addresses do not have to be accessed sequentially since  $\overline{ADS} = V_{IL}$  constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
5. If  $\overline{UB}, LB$  was HIGH, then the appropriate Byte of  $DATAOUT$  for  $Qn + 2$  would be disabled (High-Impedance state).
6. "x" denotes Left or Right port. The diagram is with respect to that port.

Timing Waveform of a Multi-Device Pipelined Read<sup>(1,2)</sup>Timing Waveform of a Multi-Device Flow-Through Read<sup>(1,2)</sup>

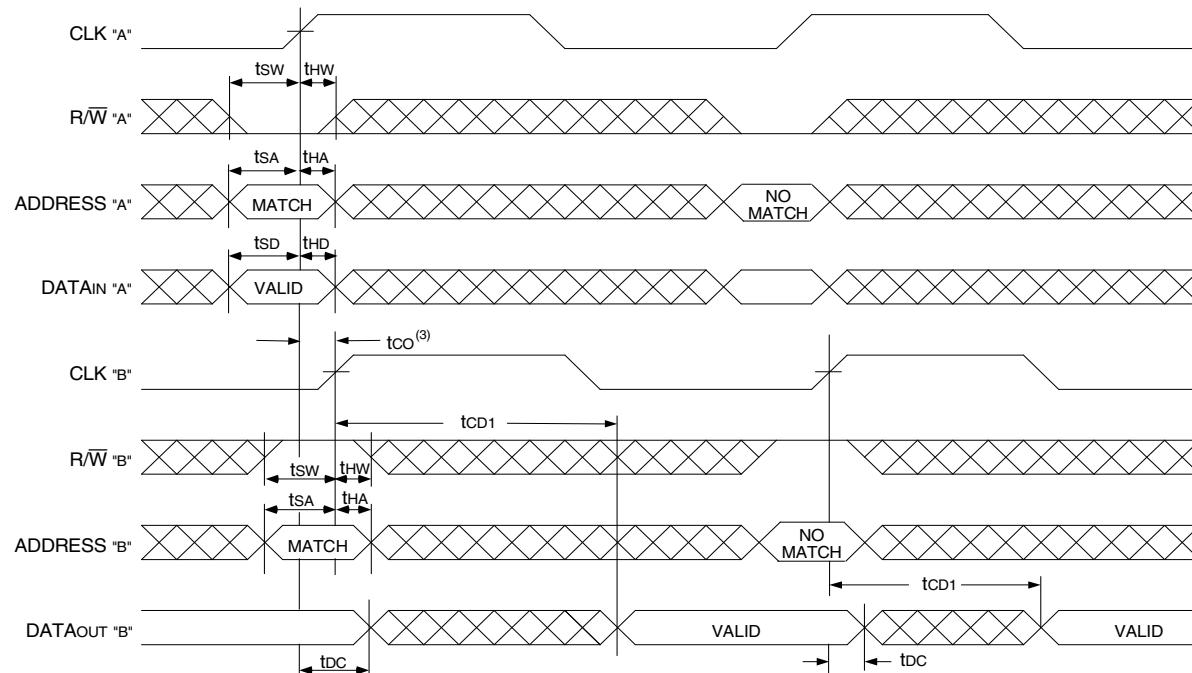
## NOTES:

1. B1 Represents Device #1; B2 Represents Device #2. Each Device consists of one IDT70V3319/99 for this waveform, and are setup for depth expansion in this example. ADDRESS(B1) = ADDRESS(B2) in this situation.
2.  $\overline{UB}$ , LB,  $\overline{OE}$ , and  $\overline{ADS}$  = V<sub>IL</sub>; CE1(B1), CE1(B2), R/W, CNTR, and  $\overline{REPEAT}$  = V<sub>IH</sub>.

Timing Waveform of Left Port Write to Pipelined Right Port Read<sup>(1,2,4)</sup>

## NOTES:

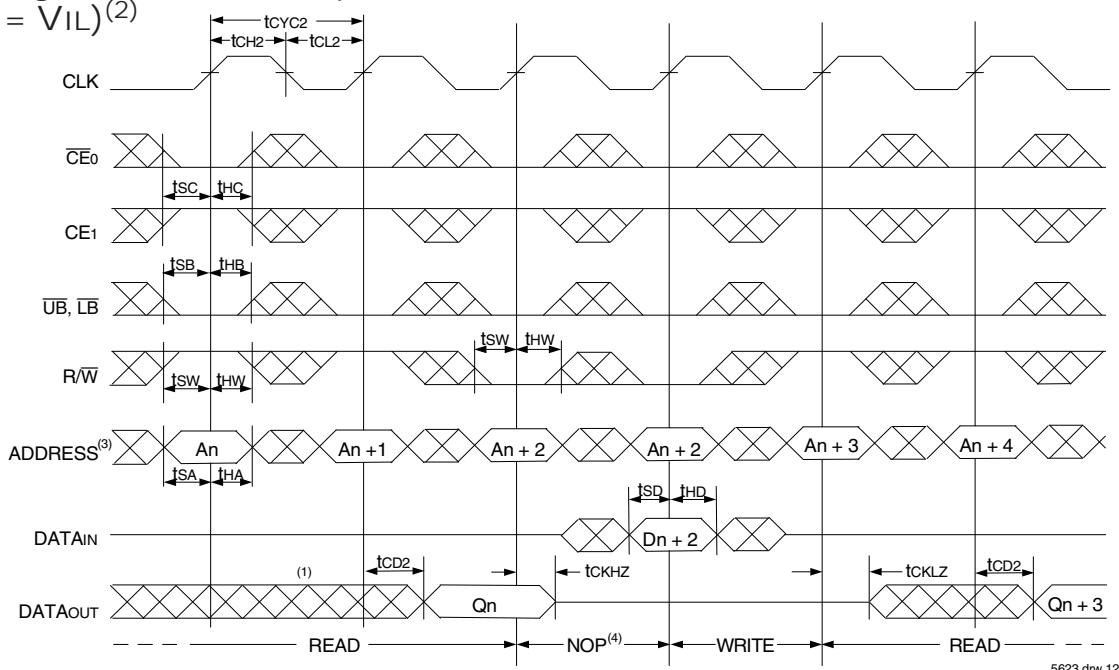
1.  $\overline{CE}_0$ ,  $\overline{UB}$ ,  $\overline{LB}$ , and  $\overline{ADS}$  =  $V_{IL}$ ;  $CE_1$ ,  $CNTEN$ , and  $\overline{REPEAT}$  =  $V_{IH}$ .
2.  $\overline{OE}$  =  $V_{IL}$  for Port "B", which is being read from.  $\overline{OE}$  =  $V_{IH}$  for Port "A", which is being written to.
3. If  $tco \leq$  minimum specified, then data from Port "B" read is not valid until following Port "B" clock cycle (i.e., time from write to valid read on opposite port will be  $tco + 2 \text{tcyc}_2 + tcd2$ ). If  $tco >$  minimum, then data from Port "B" read is available on first Port "B" clock cycle (i.e., time from write to valid read on opposite port will be  $tco + \text{tcyc}_2 + tcd2$ ).
4. All timing is the same for Left and Right ports. Port "A" may be either Left or Right port. Port "B" is the opposite of Port "A".

Timing Waveform with Port-to-Port Flow-Through Read<sup>(1,2,4)</sup>

## NOTES:

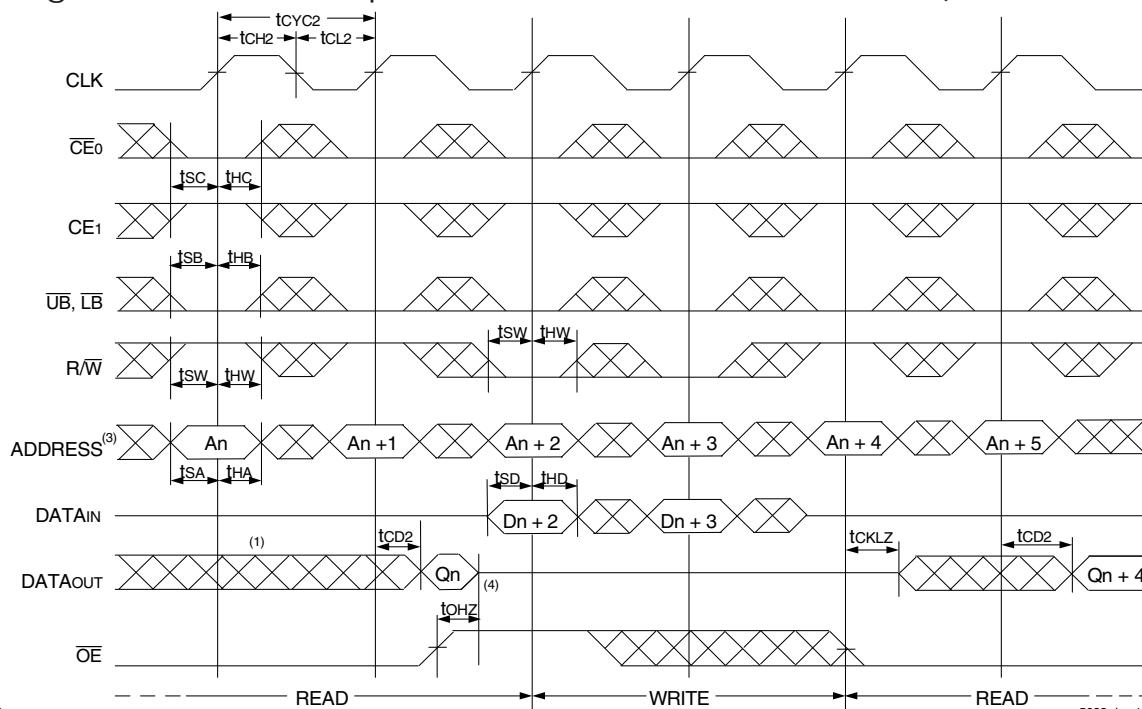
1.  $\overline{CE}_0$ ,  $\overline{UB}$ ,  $\overline{LB}$ , and  $\overline{ADS}$  =  $V_{IL}$ ;  $CE_1$ ,  $CNTEN$ , and  $\overline{REPEAT}$  =  $V_{IH}$ .
2.  $\overline{OE}$  =  $V_{IL}$  for the Right Port, which is being read from.  $\overline{OE}$  =  $V_{IH}$  for the Left Port, which is being written to.
3. If  $tco \leq$  minimum specified, then data from Port "B" read is not valid until following Port "B" clock cycle (i.e., time from write to valid read on opposite port will be  $tco + \text{tcyc} + tcd1$ ). If  $tco >$  minimum, then data from Port "B" read is available on first Port "B" clock cycle (i.e., time from write to valid read on opposite port will be  $tco + tcd1$ ).
4. All timing is the same for both left and right ports. Port "A" may be either left or right port. Port "B" is the opposite of Port "A".

## Timing Waveform of Pipelined Read-to-Write-to-Read

 $(\overline{OE} = V_{IL})^{(2)}$ 

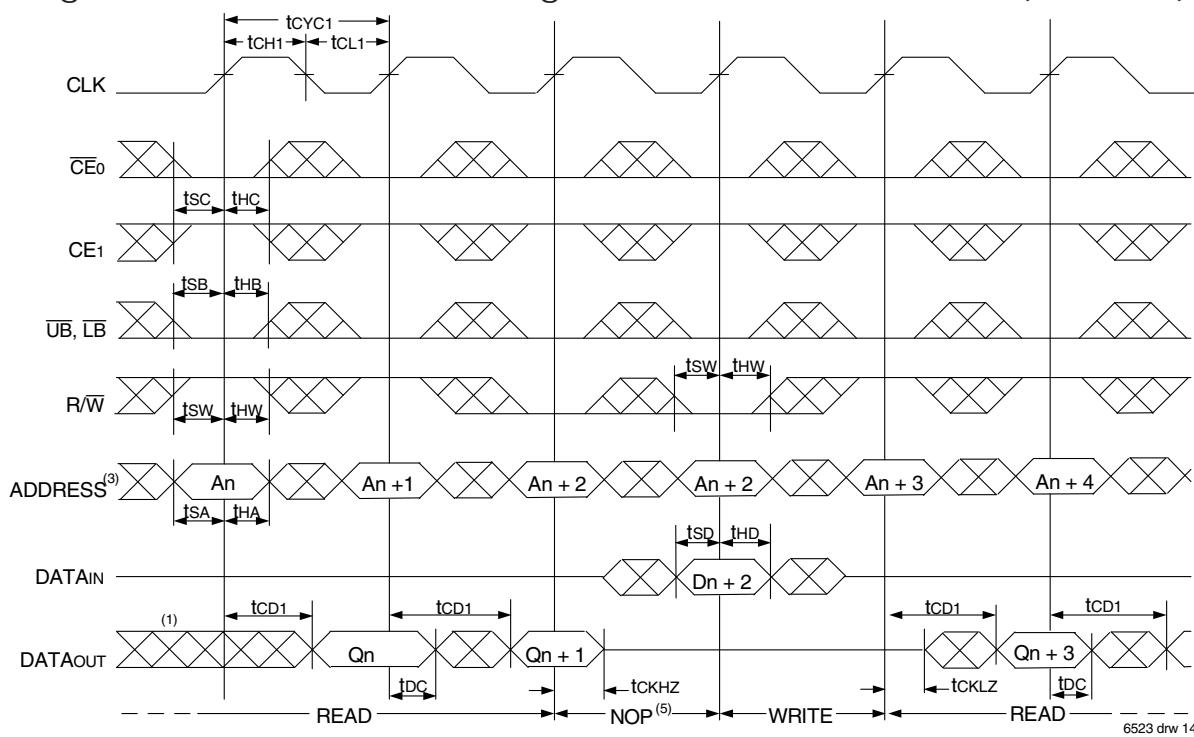
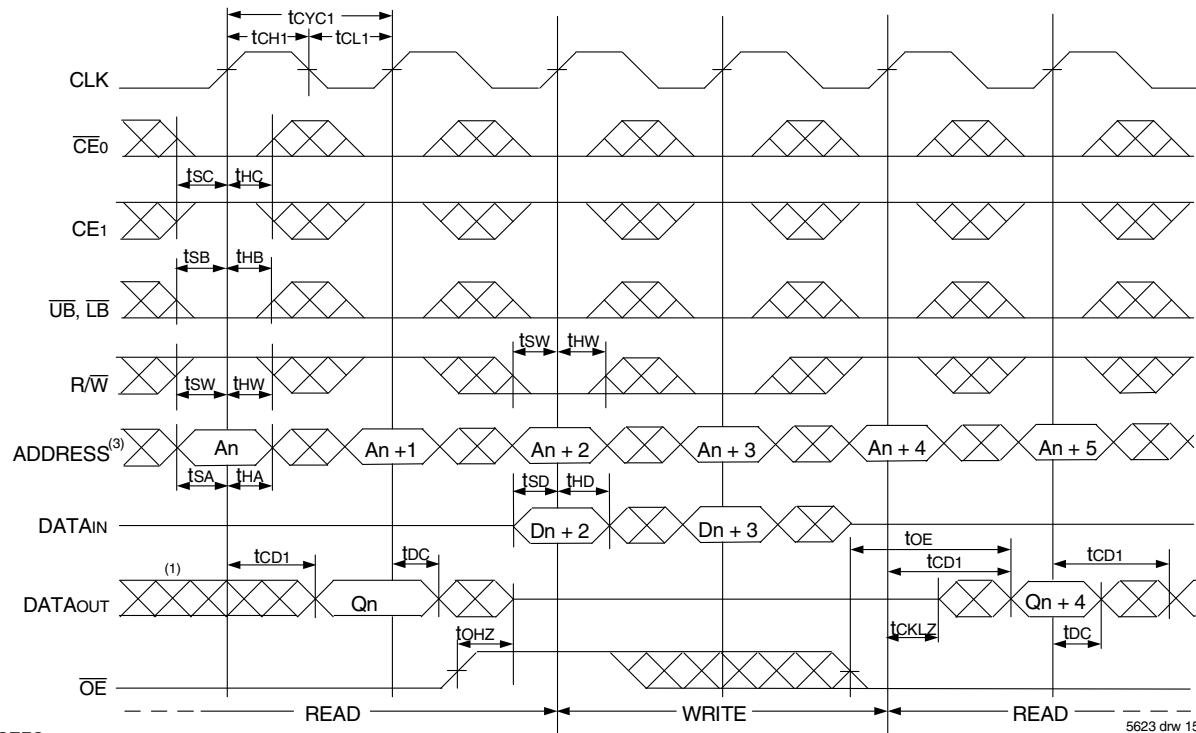
## NOTES:

1. Output state (High, Low, or High-impedance) is determined by the previous cycle control signals.
2.  $\overline{CE}_0$ ,  $\overline{UB}$ ,  $\overline{LB}$ , and  $\overline{ADS} = V_{IL}$ ;  $CE_1$ ,  $\overline{CNTEN}$ , and  $\overline{REPEAT} = V_{IH}$ . "NOP" is "No Operation".
3. Addresses do not have to be accessed sequentially since  $\overline{ADS} = V_{IL}$  constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
4. "NOP" is "No Operation." Data in memory at the selected address may be corrupted and should be rewritten to guarantee data integrity.

Timing Waveform of Pipelined Read-to-Write-to-Read ( $\overline{OE}$  Controlled)<sup>(2)</sup>

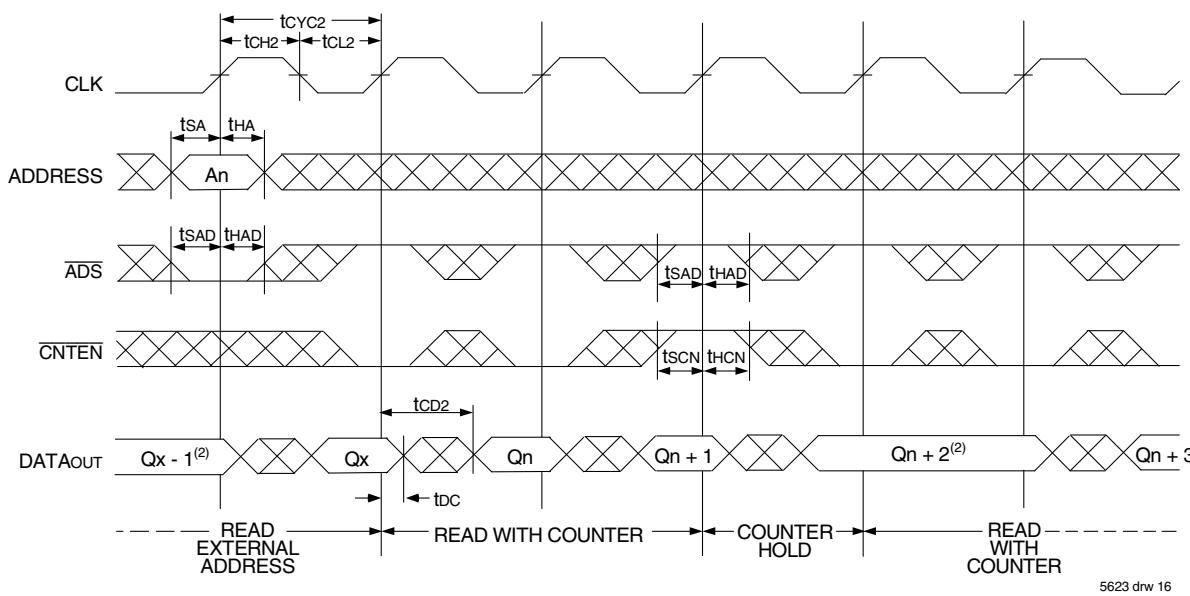
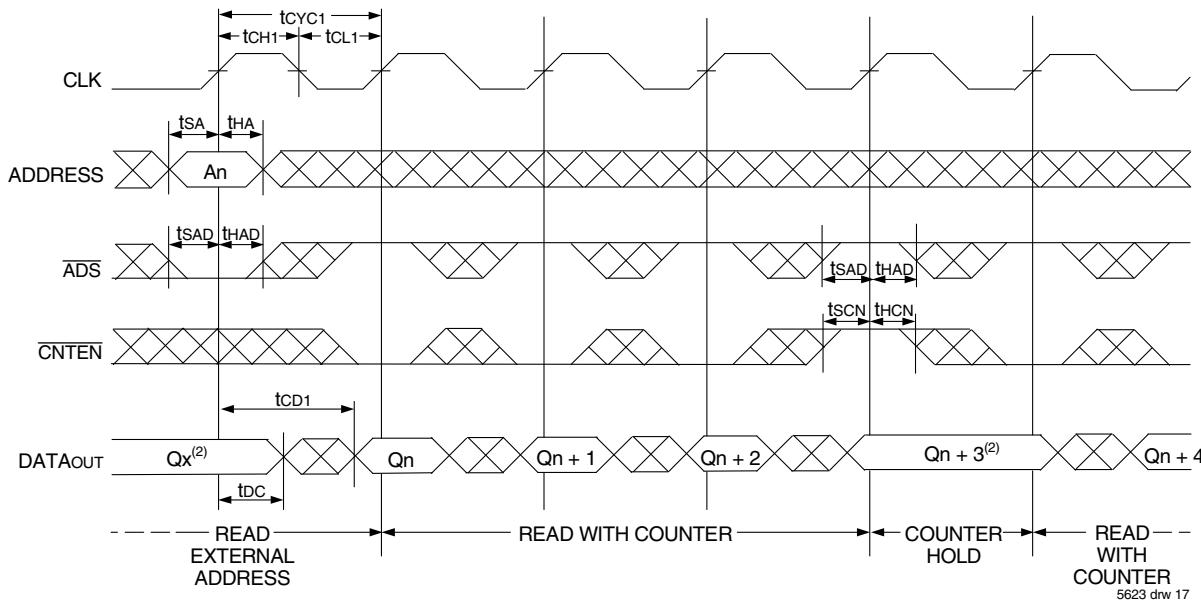
## NOTES:

1. Output state (High, Low, or High-impedance) is determined by the previous cycle control signals.
2.  $\overline{CE}_0$ ,  $\overline{UB}$ ,  $\overline{LB}$ , and  $\overline{ADS} = V_{IL}$ ;  $CE_1$ ,  $\overline{CNTEN}$ , and  $\overline{REPEAT} = V_{IH}$ .
3. Addresses do not have to be accessed sequentially since  $\overline{ADS} = V_{IL}$  constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
4. This timing does not meet requirements for fastest speed grade. This waveform indicates how logically it could be done if timing so allows.

Timing Waveform of Flow-Through Read-to-Write-to-Read ( $\overline{OE} = V_{IL}$ )<sup>(2)</sup>Timing Waveform of Flow-Through Read-to-Write-to-Read ( $\overline{OE}$  Controlled)<sup>(2)</sup>

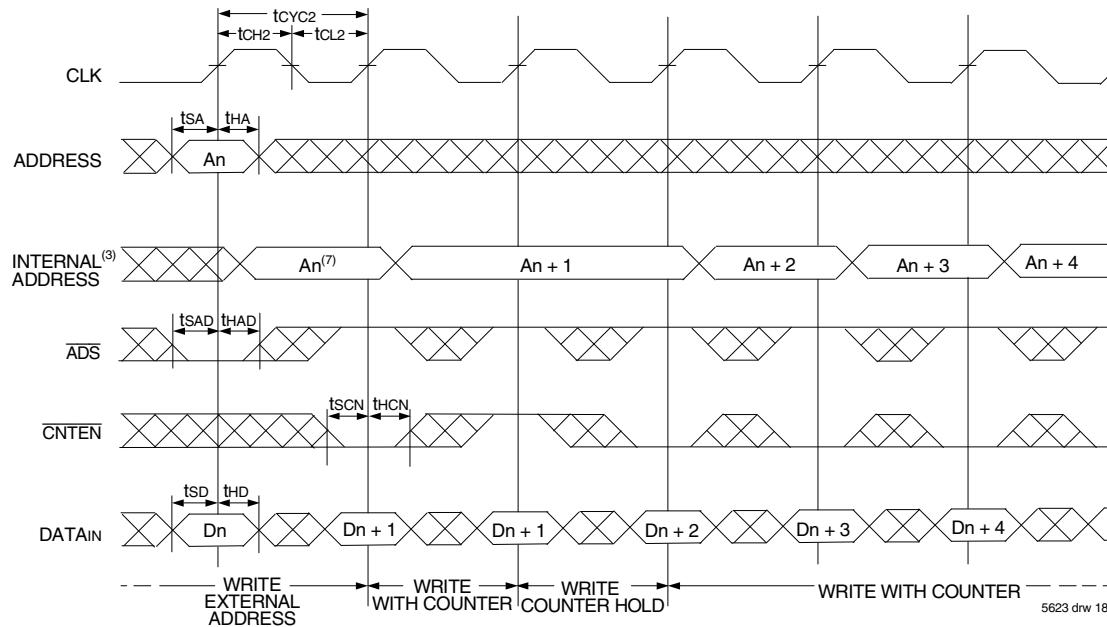
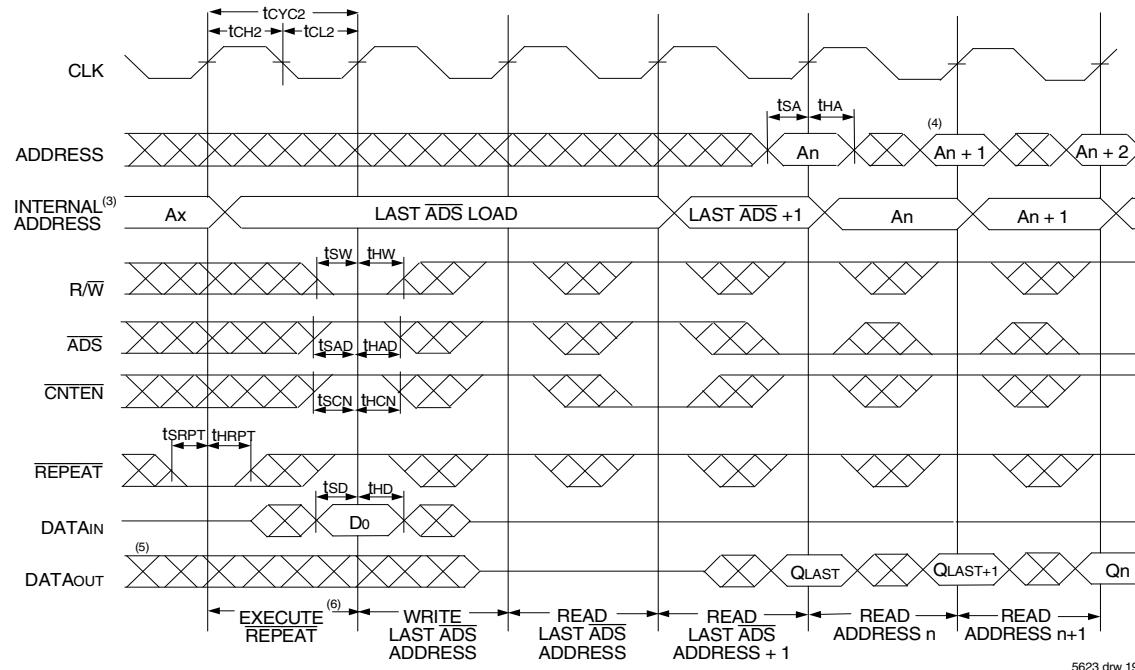
## NOTES:

1. Output state (High, Low, or High-impedance) is determined by the previous cycle control signals.
2.  $\overline{CE}_0$ ,  $\overline{UB}$ ,  $\overline{LB}$ , and  $\overline{ADS} = V_{IL}$ ;  $CE_1$ ,  $CNTEN$ , and  $\overline{REPEAT} = V_{IH}$ .
3. Addresses do not have to be accessed sequentially since  $\overline{ADS} = V_{IL}$  constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
4. "NOP" is "No Operation." Data in memory at the selected address may be corrupted and should be rewritten to guarantee data integrity.

Timing Waveform of Pipelined Read with Address Counter Advance<sup>(1)</sup>Timing Waveform of Flow-Through Read with Address Counter Advance<sup>(1)</sup>

## NOTES:

1.  $\overline{CE}_0$ ,  $\overline{OE}$ ,  $\overline{UB}$ ,  $\overline{LB}$  =  $V_{IL}$ ;  $CE_1$ ,  $R\overline{W}$ , and  $\overline{REPEAT}$  =  $V_{IH}$ .
2. If there is no address change via  $\overline{ADS} = V_{IL}$  (loading a new address) or  $\overline{CNTEN} = V_{IL}$  (advancing the address), i.e.  $\overline{ADS} = V_{IH}$  and  $\overline{CNTEN} = V_{IH}$ , then the data output remains constant for subsequent clocks.

Timing Waveform of Write with Address Counter Advance  
(Flow-through or Pipelined Inputs)<sup>(1)</sup>Timing Waveform of Counter Repeat<sup>(2)</sup>

## NOTES:

- $\overline{CE}_0$ ,  $\overline{UB}$ ,  $\overline{LB}$ , and  $\overline{R/W}$  =  $V_{IL}$ ;  $CE_1$  and  $\overline{REPEAT}$  =  $V_{IH}$ .
- $\overline{CE}_0$ ,  $\overline{UB}$ ,  $\overline{LB}$  =  $V_{IL}$ ;  $CE_1$  =  $V_{IH}$ .
- The "Internal Address" is equal to the "External Address" when  $\overline{ADS} = V_{IL}$  and equals the counter output when  $\overline{ADS} = V_{IH}$ .
- Addresses do not have to be accessed sequentially since  $\overline{ADS} = V_{IL}$  constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
- Output state (High, Low, or High-impedance) is determined by the previous cycle control signals.
- No dead cycle exists during  $\overline{REPEAT}$  operation. A READ or WRITE cycle may be coincidental with the counter  $\overline{REPEAT}$  cycle: Address loaded by last valid  $\overline{ADS}$  load will be accessed. Extra cycles are shown here simply for clarification. For more information on  $\overline{REPEAT}$  function refer to Truth Table II.
- $CNTEN = V_{IL}$  advances Internal Address from 'An' to 'An +1'. The transition shown indicates the time required for the counter to advance. The 'An +1' Address is written to during this cycle.

## Functional Description

The IDT70V3319/99 provides a true synchronous Dual-Port Static RAM interface. Registered inputs provide minimal set-up and hold times on address, data, and all critical control inputs. All internal registers are clocked on the rising edge of the clock signal, however, the self-timed internal write pulse is independent of the LOW to HIGH transition of the clock signal.

An asynchronous output enable is provided to ease asynchronous bus interfacing. Counter enable inputs are also provided to stall the operation of the address counters for fast interleaved memory applications.

A HIGH on  $\overline{CE}_0$  or a LOW on  $CE_1$  for one clock cycle will power down the internal circuitry to reduce static power consumption. Multiple chip enables allow easier banking of multiple IDT70V3319/99s for depth expansion configurations. Two cycles are required with  $\overline{CE}_0$  LOW and  $CE_1$  HIGH to reactivate the outputs.

## Depth and Width Expansion

The IDT70V3319/99 features dual chip enables (refer to Truth Table I) in order to facilitate rapid and simple depth expansion with no requirements for external logic. Figure 4 illustrates how to control the various chip enables in order to expand two devices in depth.

The IDT70V3319/99 can also be used in applications requiring expanded width, as indicated in Figure 4. Through combining the control signals, the devices can be grouped as necessary to accommodate applications needing 36-bits or wider.

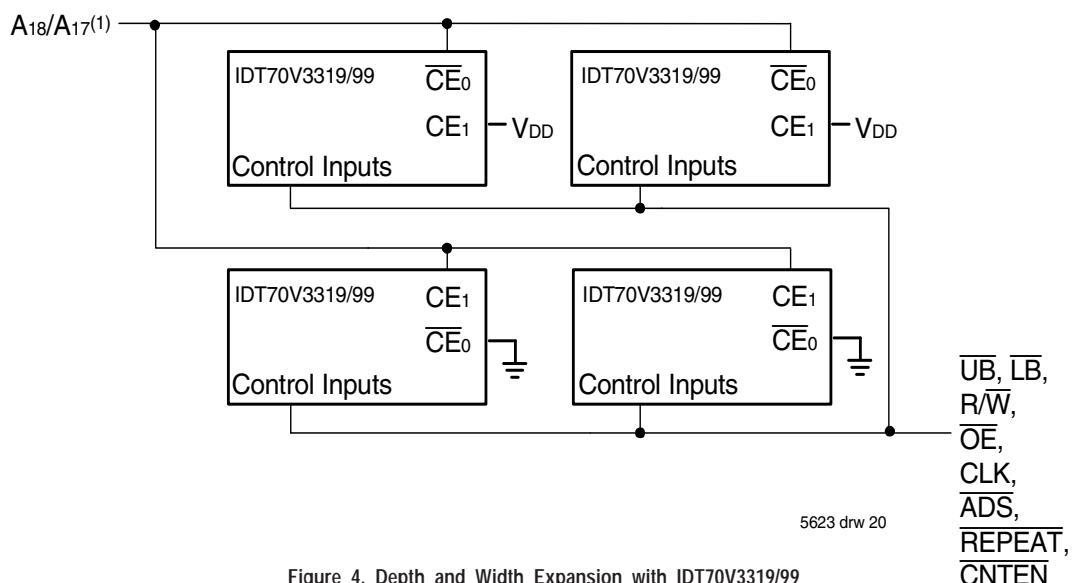


Figure 4. Depth and Width Expansion with IDT70V3319/99

### NOTE:

1. A17 is for IDT70V3319, A16 is for IDT70V3399.

## JTAG Timing Specifications

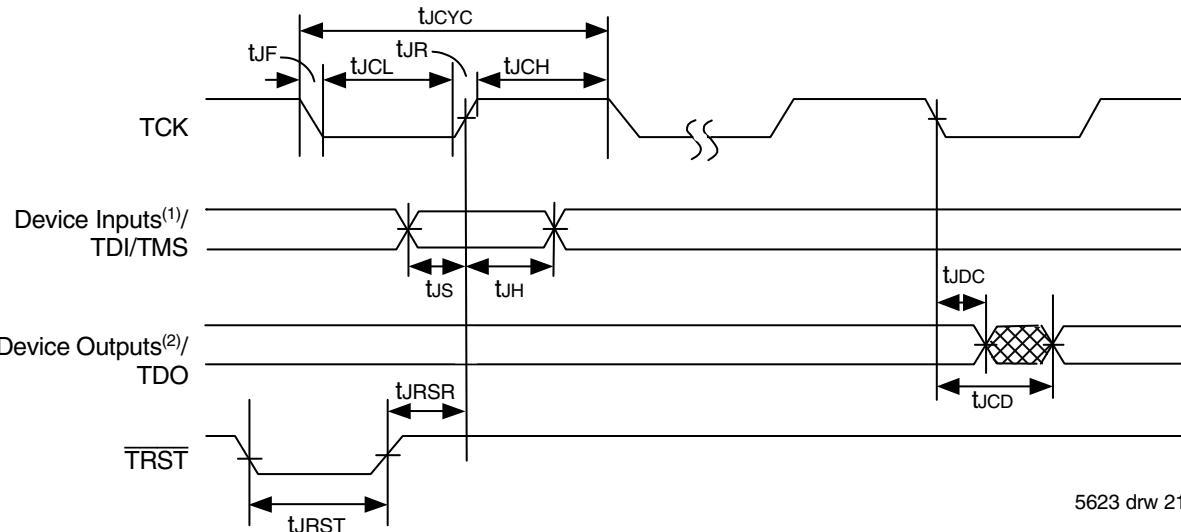


Figure 5. Standard JTAG Timing

## NOTES:

1. Device inputs = All device inputs except TDI, TMS, and TRST.
2. Device outputs = All device outputs except TDO.

JTAG AC Electrical Characteristics<sup>(1,2,3,4)</sup>

Symbol	Parameter	70V3319/99		
		Min.	Max.	Units
tJCYC	JTAG Clock Input Period	100	—	ns
tJCH	JTAG Clock HIGH	40	—	ns
tJCL	JTAG Clock Low	40	—	ns
tJR	JTAG Clock Rise Time	—	3 <sup>(1)</sup>	ns
tJF	JTAG Clock Fall Time	—	3 <sup>(1)</sup>	ns
tJRST	JTAG Reset	50	—	ns
tJRSR	JTAG Reset Recovery	50	—	ns
tJCD	JTAG Data Output	—	25	ns
tJDC	JTAG Data Output Hold	0	—	ns
tJS	JTAG Setup	15	—	ns
tJH	JTAG Hold	15	—	ns

5623 tbl 12

## NOTES:

1. Guaranteed by design.
2. 30pF loading on external output signals.
3. Refer to AC Electrical Test Conditions stated earlier in this document.
4. JTAG operations occur at one speed (10MHz). The base device may run at any speed specified in this datasheet.

## Identification Register Definitions

Instruction Field	Value	Description
Revision Number (31:28)	0x0	Reserved for version number
IDT Device ID (27:12)	0x0314 <sup>(1)</sup>	Defines IDT part number
IDT JEDEC ID (11:1)	0x33	Allows unique identification of device vendor as IDT
ID Register Indicator Bit (Bit 0)	1	Indicates the presence of an ID register

## NOTE:

1. Device ID for IDT70V3399 is 0x0315.

5623 tbl 13

## Scan Register Sizes

Register Name	Bit Size
Instruction (IR)	4
Bypass (BYR)	1
Identification (IDR)	32
Boundary Scan (BSR)	Note (3)

5623 tbl 14

## System Interface Parameters

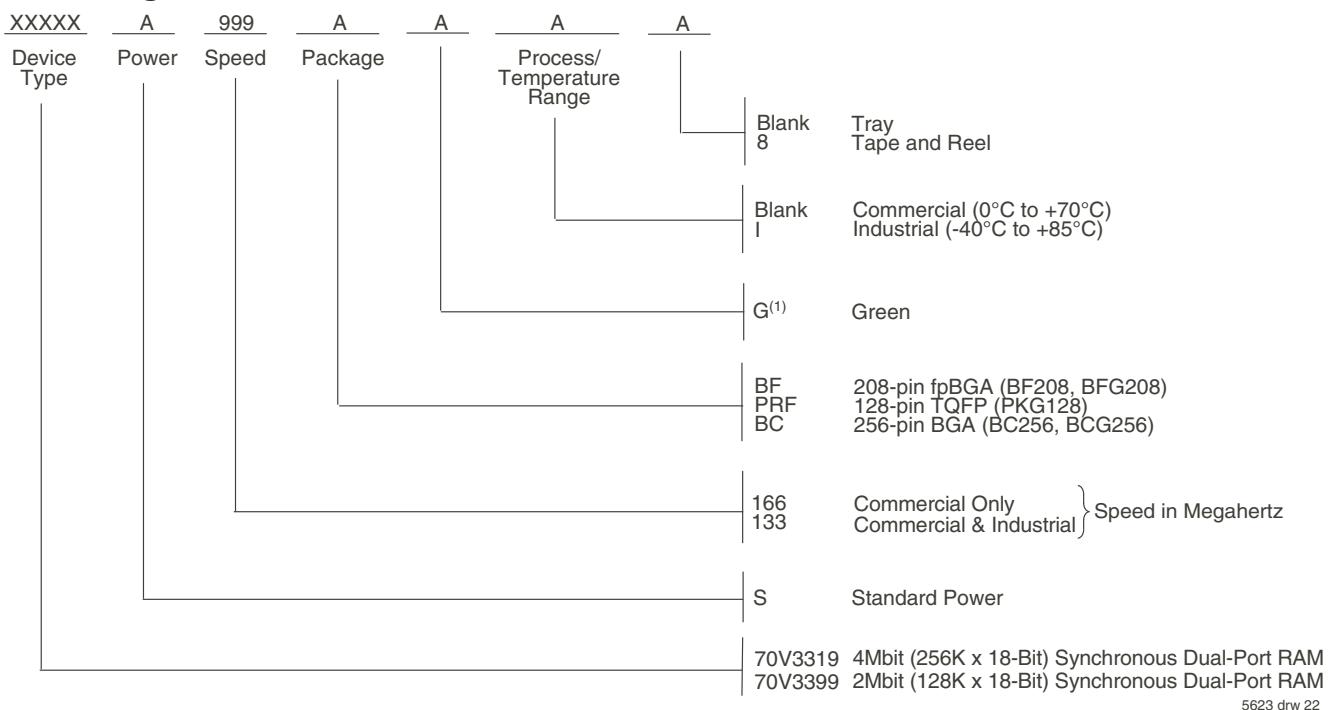
Instruction	Code	Description
EXTEST	0000	Forces contents of the boundary scan cells onto the device outputs <sup>(1)</sup> . Places the boundary scan register (BSR) between TDI and TDO.
BYPASS	1111	Places the bypass register (BYR) between TDI and TDO.
IDCODE	0010	Loads the ID register (IDR) with the vendor ID code and places the register between TDI and TDO.
HIGHZ	0011	Places the bypass register (BYR) between TDI and TDO. Forces all device output drivers to a High-Z state.
SAMPLE/PRELOAD	0001	Places the boundary scan register (BSR) between TDI and TDO. SAMPLE allows data from device inputs <sup>(2)</sup> to be captured in the boundary scan cells and shifted serially through TDO. PRELOAD allows data to be input serially into the boundary scan cells via the TDI.
RESERVED	All other codes	Several combinations are reserved. Do not use codes other than those identified above.

5623 tbl 15

## NOTES:

1. Device outputs = All device outputs except TDO.
2. Device inputs = All device inputs except TDI, TMS, and  $\overline{\text{TRST}}$ .
3. The Boundary Scan Descriptive Language (BSDL) file for this device is available on the IDT website ([www.idt.com](http://www.idt.com)), or by contacting your local IDT sales representative.

## Ordering Information



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## NOTES:

1. Contact your local sales office for industrial temp. range for other speeds, packages and powers.

LEAD FINISH (SnPb) parts are Obsolete excluding BGA & fpBGA. Product Discontinuation Notice - PDN# SP-17-02

Note that information regarding recently obsolete parts is included in this datasheet for customer convenience.

## Orderable Part Information

Speed (MHz)	Orderable Part ID	Pkg. Code	Pkg. Type	Temp. Grade
133	70V3319S133BC	BC256	CABGA	C
	70V3319S133BC8	BC256	CABGA	C
	70V3319S133BCGI	BCG256	CABGA	I
	70V3319S133BCI	BC256	CABGA	I
	70V3319S133BCI8	BC256	CABGA	I
	70V3319S133BF	BF208	CABGA	C
	70V3319S133BF8	BF208	CABGA	C
	70V3319S133BFI	BF208	CABGA	I
	70V3319S133BFI8	BF208	CABGA	I
	70V3319S133PRFGI	PKG128	TQFP	I
166	70V3319S133PRFGI8	PKG128	TQFP	I
	70V3319S166BC	BC256	CABGA	C
	70V3319S166BC8	BC256	CABGA	C
	70V3319S166BCG	BCG256	CABGA	C
	70V3319S166BF	BF208	CABGA	C
	70V3319S166BF8	BF208	CABGA	C
	70V3319S166BFG	BFG208	CABGA	C
	70V3319S166BFG8	BFG208	CABGA	C
166	70V3319S166PRFG	PKG128	TQFP	C
	70V3319S166PRFG8	PKG128	TQFP	C

Speed (MHz)	Orderable Part ID	Pkg. Code	Pkg. Type	Temp. Grade
133	70V3399S133BC	BC256	CABGA	C
	70V3399S133BC8	BC256	CABGA	C
	70V3399S133BCI	BC256	CABGA	I
	70V3399S133BCI8	BC256	CABGA	I
	70V3399S133BF	BF208	CABGA	C
	70V3399S133BF8	BF208	CABGA	C
	70V3399S133BFI	BF208	CABGA	I
	70V3399S133BFI8	BF208	CABGA	I
166	70V3399S166BC	BC256	CABGA	C
	70V3399S166BC8	BC256	CABGA	C
	70V3399S166BF	BF208	CABGA	C
	70V3399S166BF8	BF208	CABGA	C
	70V3399S166BFG	BFG208	CABGA	C
	70V3399S166BFG8	BFG208	CABGA	C

## Datasheet Document History:

06/02/00: Initial Public Offering

07/12/00: Page 1 Added mux to functional block diagram

06/20/01: Page 1 Added JTAG information for TQFP package

07/30/01: Page 4 Corrected TQFP package size  
Page 1 Added PL/FToption  
Page 20 Changed maximum value for JTAG AC Electrical Characteristics for  $t_{JCD}$  from 20ns to 25ns  
Page 9 Added Industrial Temperature DC Parameters

11/20/01: Page 2, 3 & 4 Added date revision for pin configurations  
Page 11 Changed  $t_{OE}$  value in AC Electrical Characteristics, please refer to Errata #SMEN-01-05  
Page 1 & 22 Replaced  $\text{TM}$  logo with  $\text{TM}$  logo  
Page 10 Changed AC Test Conditions Input Rise/Fall Times

08/06/02: Consolidated multiple devices into one datasheet  
Page 1 & 5 Added DCD capability for Pipelined Outputs  
Page 7 Clarified  $T_{BIAS}$  and added  $T_{JN}$   
Page 9 Changed DC Electrical Parameters  
Page 11 Removed Clock Rise & Fall Time from AC Electrical Characteristics Table  
Removed Preliminary status

05/19/03: Page 11 Added Byte Enable SetupTime & Byte Enable Hold Time to AC Electrical Characteristics Table  
Page 22 Added IDT Clock Solution Table

02/08/06: Page 1 Added green availability to features  
Page 6 Changed footnote 2 for Truth Table I from  $\overline{\text{ADS}}, \overline{\text{CNTEN}}, \overline{\text{REPEAT}} = V_{IH}$  to  $\overline{\text{ADS}}, \overline{\text{CNTEN}}, \overline{\text{REPEAT}} = X$   
Page 22 Added green indicator to ordering information

07/25/08: Page 9 Corrected a typo in the DC Chars table

01/19/09: Page 22 Removed "IDT" from orderable part number

10/03/14: Page 22 Added Tape & Reel to the Ordering Information

06/20/18: Product Discontinuation Notice - PDN# SP-17-02  
Last time buy expires June 15, 2018

09/12/19: Page 2, 3 & 4 Updated package codes  
Page 22 Added Orderable Part Information table and removed IDT Clock Solution table

11/04/19: Page 22 Corrected "ns" to "MHz" in the header of the Orderable Part Information tables

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